



## **Analysis of the 12<sup>th</sup> ECG-COMON Round-Robin on dummy cells**

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## Round-Robin on Electrochemical Noise #12

- 3 identical resistors in star arrangement (ZRA mode)
  - $R = 1 \text{ M}\Omega$  and  $R = 100 \text{ M}\Omega$
  - thermal noise : low but known ( $\Psi_V = 6kTR$ ,  $\Psi_I = 2kT/R$ )
- 
- 20 participants: missing PalmSens
  - 24 data sets received (4 for CANMET, 2 for VTT, CNRS)

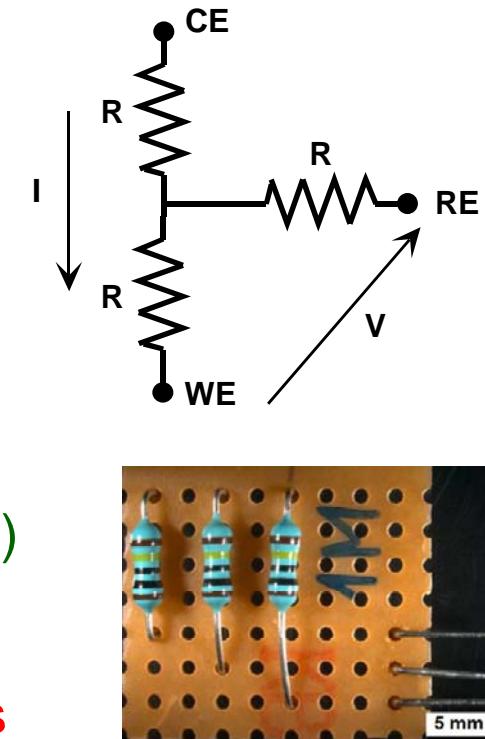


total: 149 files, 298 time records, 298 PSDs

Analysis performed in frequency domain (FFT as in last RR test):

- only way to validate EN measurements
- measurements have to be performed at different sampling frequencies (2 to 4 for all participants)

Aim: compare the new results with those measured in 2014 and 2016



## Hardware and software used in RR #12

Organisation	Contact person	Device and software
AREVA (Germany)	Matthias Herbst	Gamry Ref600, ESA410
<b>Bio-logic (France)</b>	Nicolas Murer	Bio-Logic SP-300, EC-Lab Express 5.56
Canmet Materials (Canada)	Jennifer Collier	Solartron 1287A , CorrWare (2 instruments)
Canmet Materials (Canada)	Jean-Philippe Gravel	Solartron 1287A, CorrWare + PAR Parstat, Ver.Stud. 2.5
CEA Saclay (France)	Benoit Gwinner	Bio-Logic SP-200, EC-Lab V10.40
CETIM Mulhouse (France)	Xavier Ledoux	Gamry Ref600+, ESA410
CNRS (France)	Kieu ngo	Maxion + Gamry Ref600, ESA410
Curtin (Australia)	Yang Hou	Gamry Ref600, ESA410 v6.25
<b>Gamry (USA)</b>	Dominik Moosbauer	Gamry Ref600+, ESA410 v7.04
HRL Laboratories (USA)	John Vajo	Solartron 1287 , CorrWare
INSA Lyon (France)	José Bolivar	Gamry Ref600+, ESA410 v7.03
<b>IPS (Germany)</b>	Peter Schrems	IPS PGU 10V-1A-IMP-S
IRSN, Cadarache (France)	Walter John Chitty	Gamry Ref600+, ESA410
NNL (England)	Jordan Knapp	Gamry Ref600, ESA410
PSI (Switzerland)	Stefan Ritter	IPS EcmNoise
Rolls-Royce (England)	Tony Horner	ACM, ACM Instruments v5
SIKA (Switzerland)	Bakalli Mirdash	Gamry Ref600, ESA410 v7.03
VTT (Finland)	Konsta Sipilä	Gamry Ref600, EN120 and ESA410
WITg (Switzerland)	Arnulf Hörtnagl	IPS PGU 10V-1A-IMP-S, EcmWin v 2.6.1
ZAG (Slovenia)	Bojan Zajec	IPS HRU/ZRA FG-B-2M

3 manufacturers

11 Gamry, 4 Solartron, 2 Bio-logic, 4 IPS, 1 Maxion,  
1 PAR (Ametek), 1 ACM

## Algorithm for PSD calculation with FFT

in this work: each time record divided in N sections of M = 512 data points

N = int(number of data in the file / 512): from 8 to 350

loop N times

{

acquisition of M data points of  $x(t)$

linear detrending

remove the mean value of  $x$  (not informative since

corresponds to frequency 0)

multiply by the Hann window

FFT

PSD calculation:

}

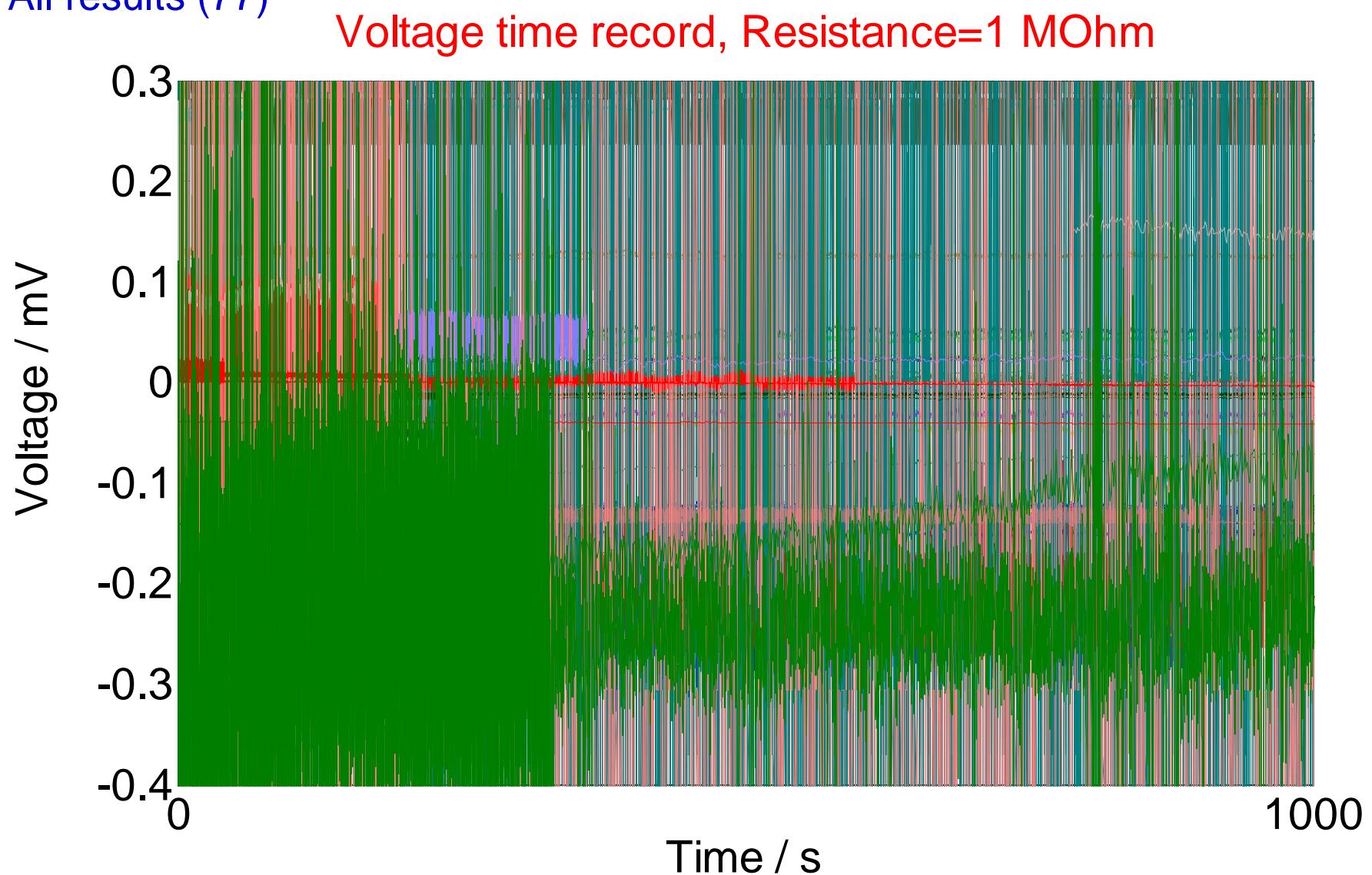
$$\Psi_x(m\Delta f) = \frac{2}{T} |X_T(m\Delta f)|^2 = \frac{2}{M} \Delta t \left| \sum_{n=0}^{M-1} x(n\Delta t) e^{-2i\pi m n / M} \right|^2$$

average the N PSDs

if Hann: multiply the result by 8/3.

## Part 1 – RR12: analysis of the voltage time records ( $R = 1 \text{ M}\Omega$ )

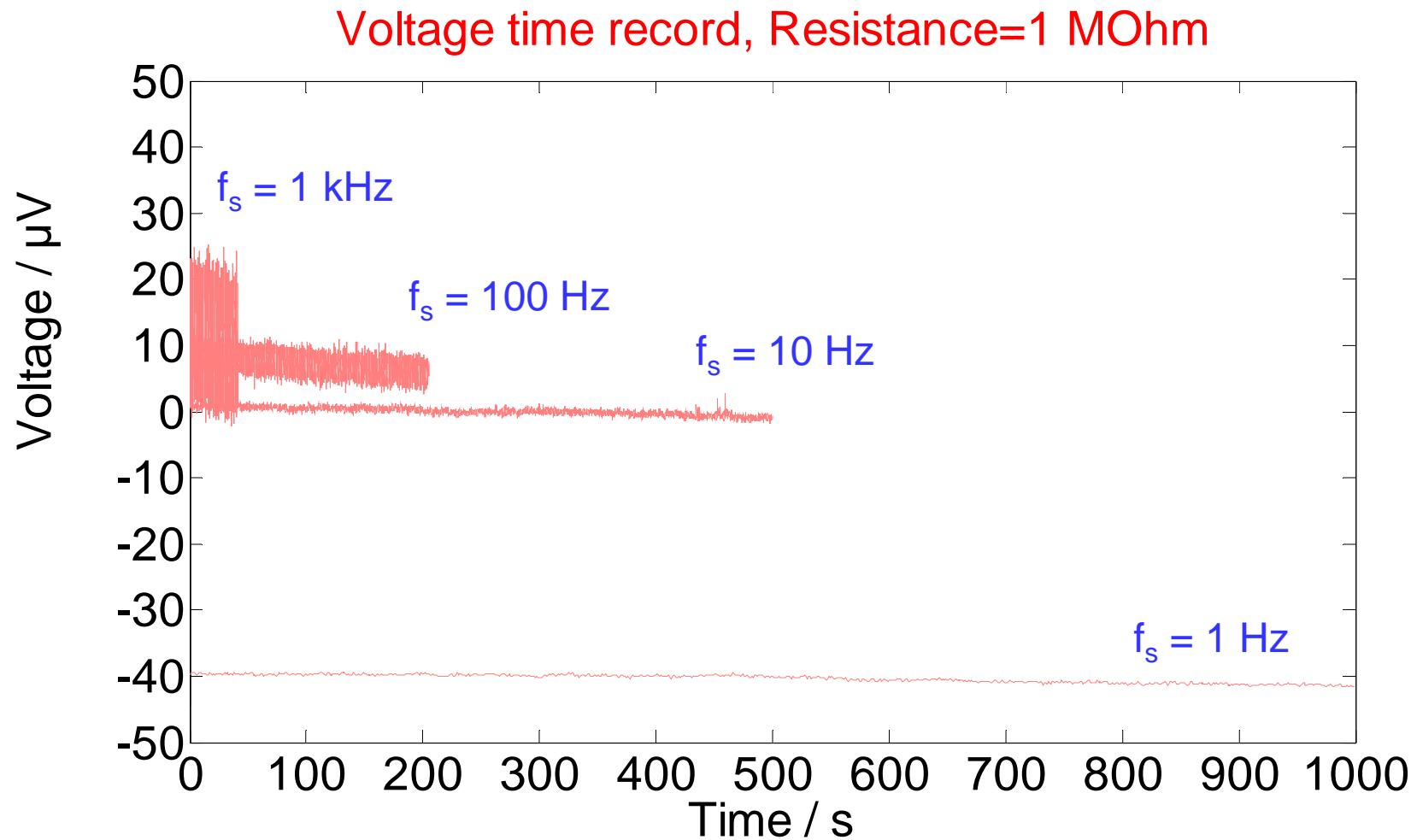
All results (77)



quite impossible to see all time records in the same plot

## Part 1: analysis of the voltage time records ( $R = 1 \text{ M}\Omega$ )

Maxion (4)

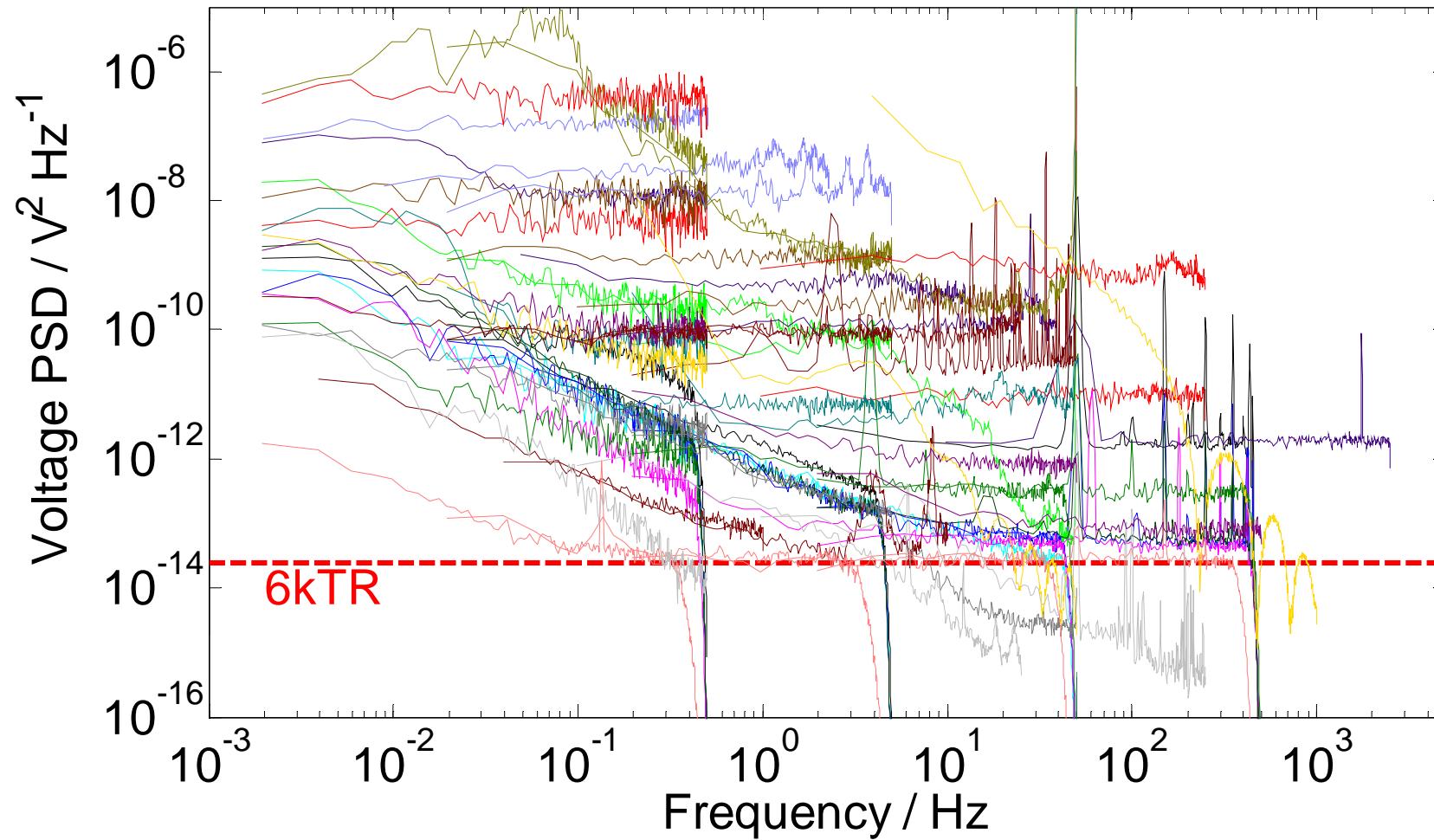


difficult to analyze a white noise in the time domain  $\rightarrow$  frequency domain

# Part 1 – RR8 – 2014: analysis of the voltage PSDs ( $R = 1 \text{ M}\Omega$ )

All results but 4 (65)

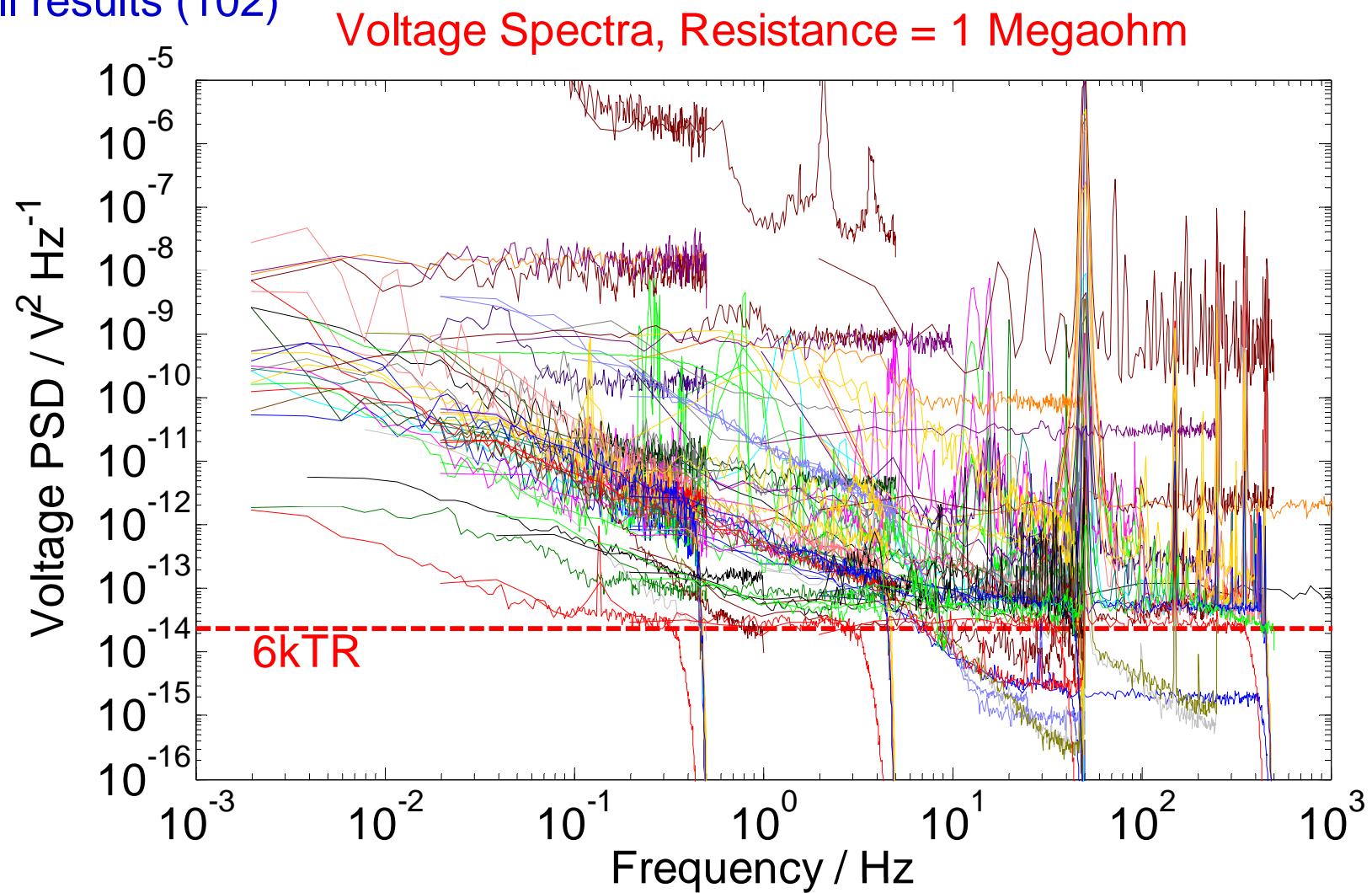
Voltage Spectra, Resistance = 1 Megaohm



large scatter: not better than PSD measured before 2008 (round-robin paper)

## Part 1 – RR11 – 2016: analysis of the voltage PSDs ( $R = 1 \text{ M}\Omega$ )

All results (102)

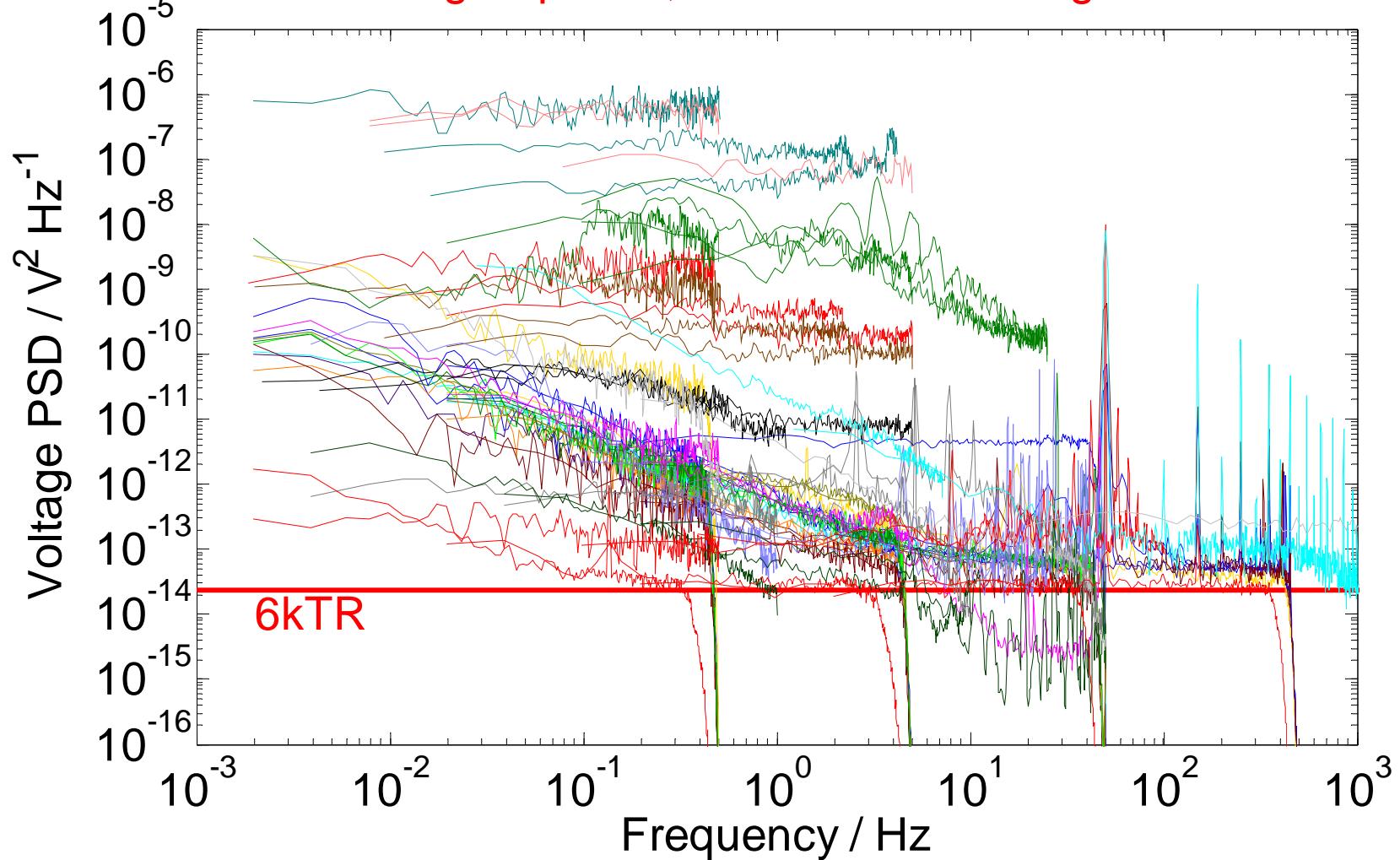


large scatter: not better than PSD measured in 2014

# Part 1 – RR12 – 2017: analysis of the voltage PSDs ( $R = 1 \text{ M}\Omega$ )

All results (77)

Voltage Spectra, Resistance = 1 Megaohm

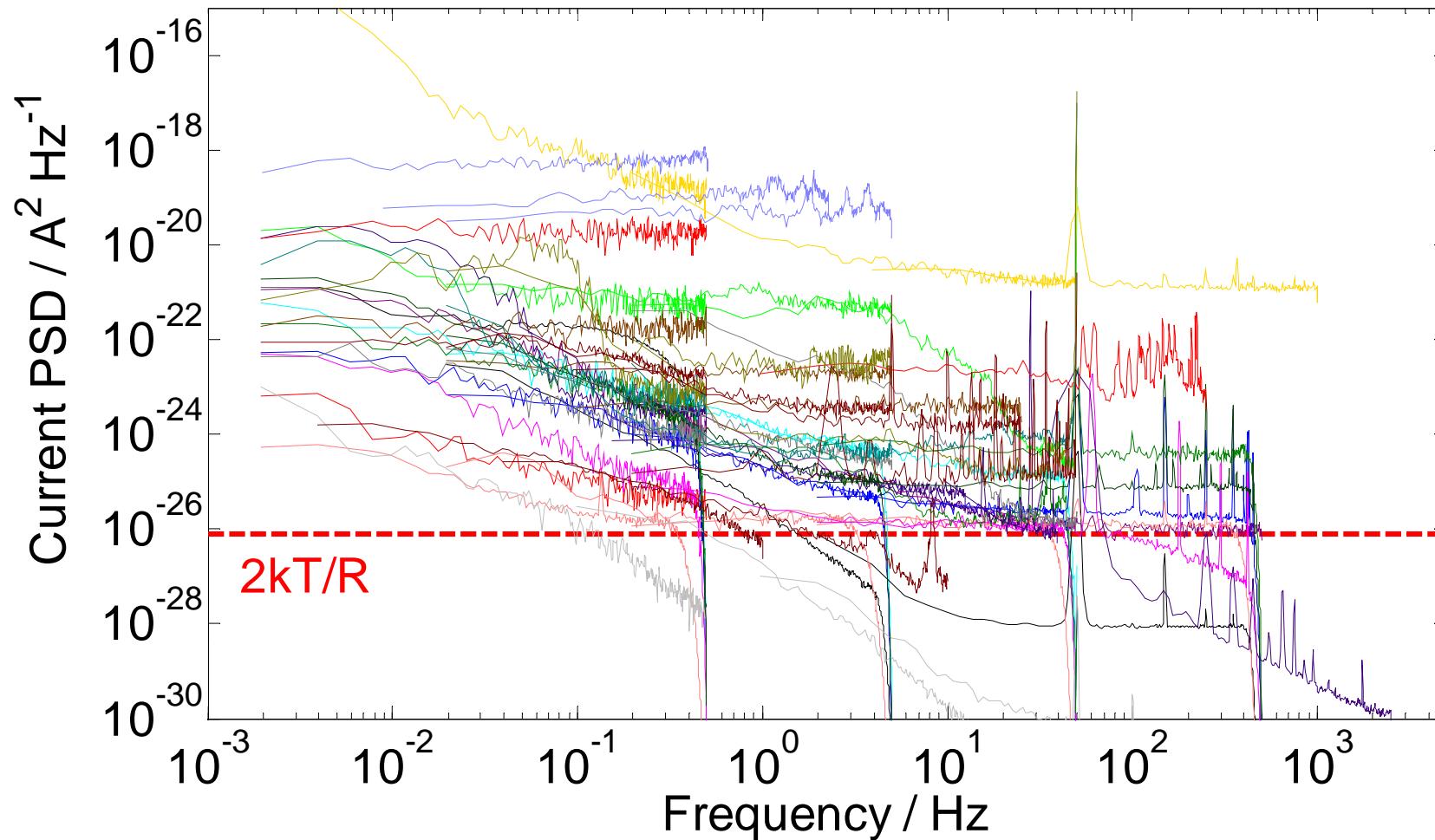


large scatter: not better than PSD measured in 2016

## Part 2 – RR8 – 2014: analysis of the current PSDs ( $R = 1 \text{ M}\Omega$ )

All results but 6 (63)

Current Spectra, Resistance = 1 Megaohm

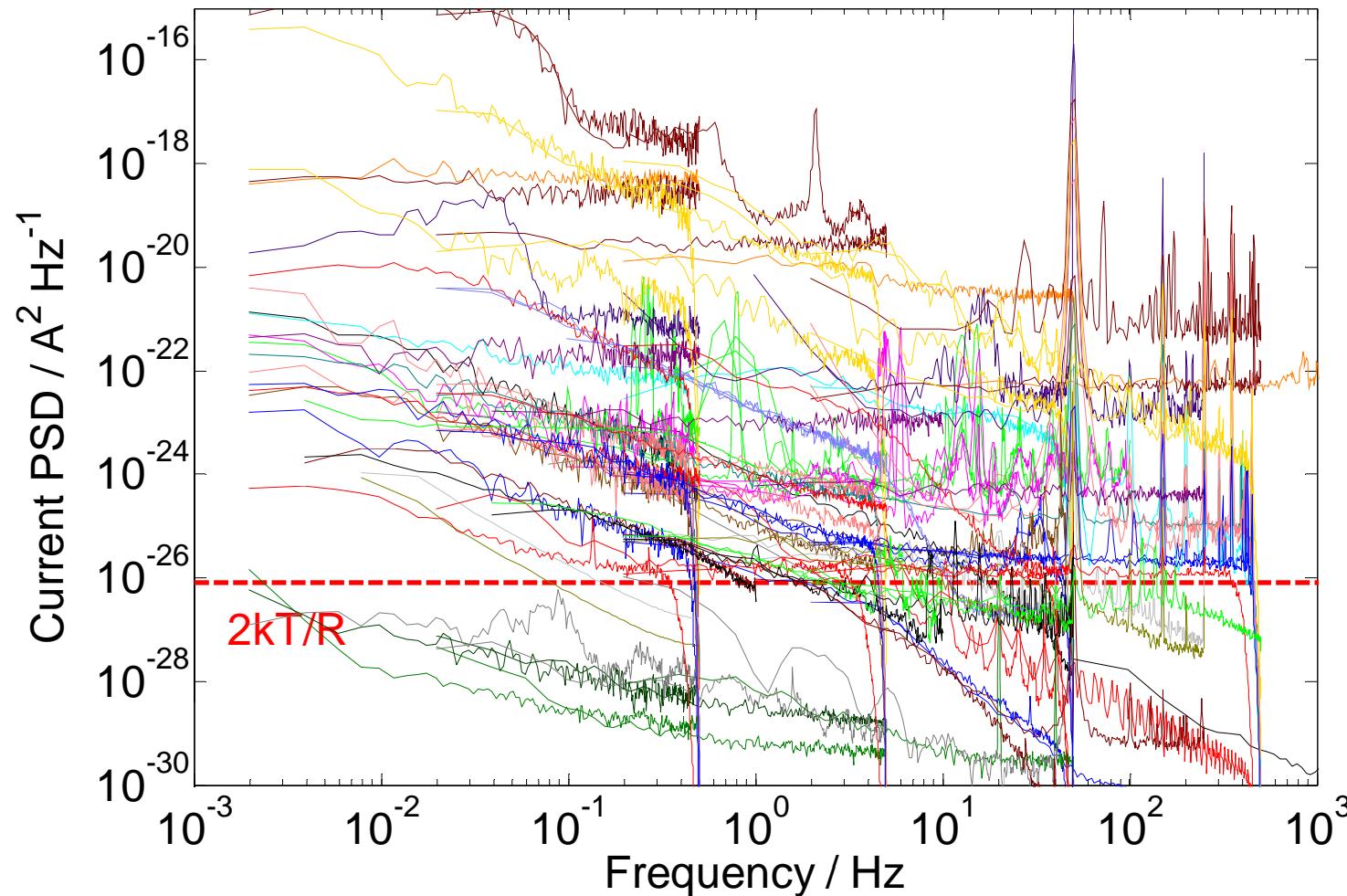


large scatter: not better than PSD measured before 2008 (round-robin paper)

## Part 2 – RR11 – 2016: analysis of the current PSDs ( $R = 1 \text{ M}\Omega$ )

All results (102)

Current Spectra, Resistance = 1 Megaohm

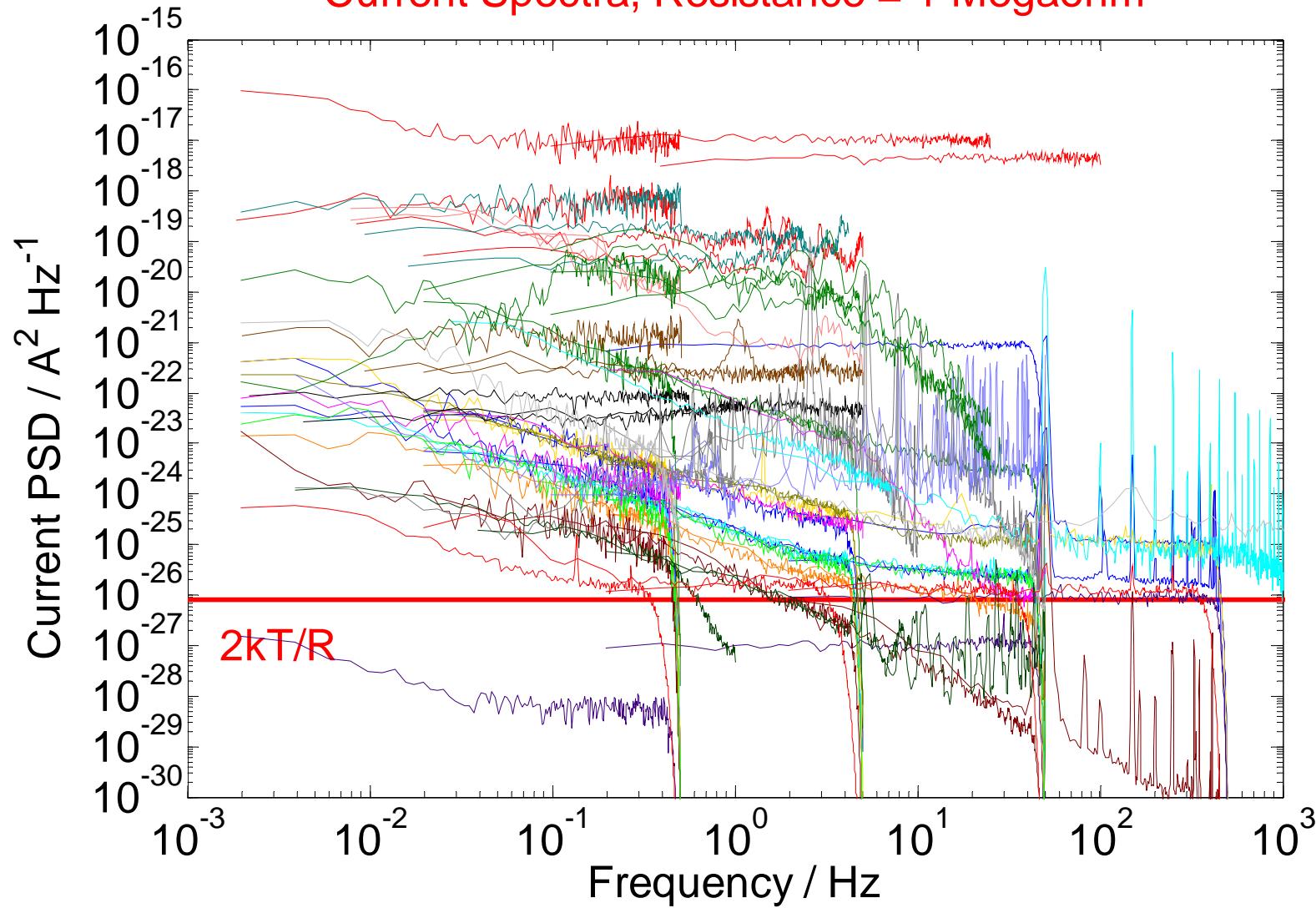


large scatter: not better than PSD measured in 2014

## Part 2 – RR12 – 2017: analysis of the current PSDs ( $R = 1 \text{ M}\Omega$ )

All results (77)

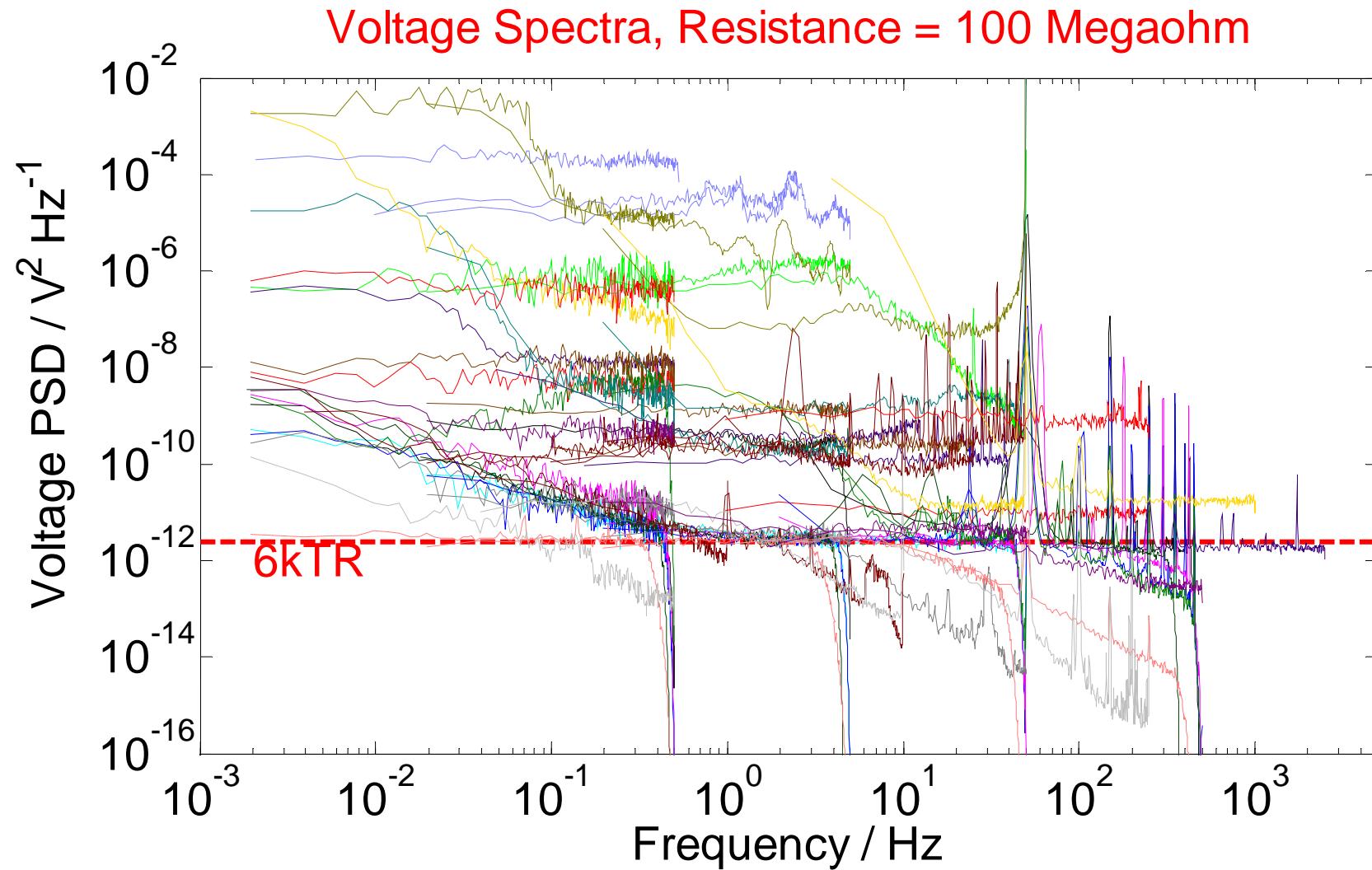
Current Spectra, Resistance = 1 Megaohm



large scatter: not better than PSD measured in 2016

## Part 3 – RR8 – 2014: analysis of the voltage PSDs ( $R = 100 \text{ M}\Omega$ )

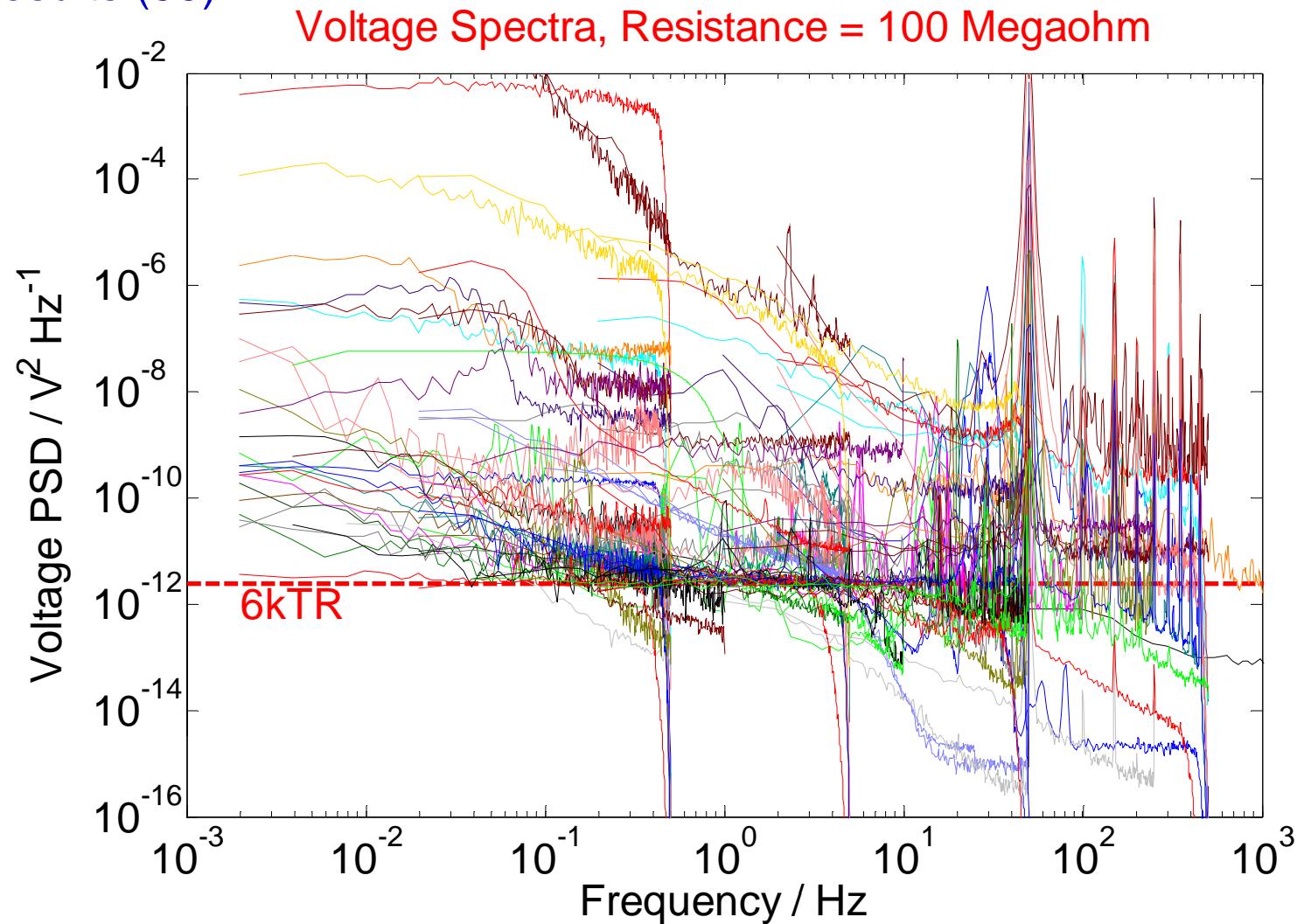
All results but 5 (64)



still large scatter while the voltage noise PSD is 100 times higher

## Part 3 – RR11 – 2016: analysis of the voltage PSDs ( $R = 100 \text{ M}\Omega$ )

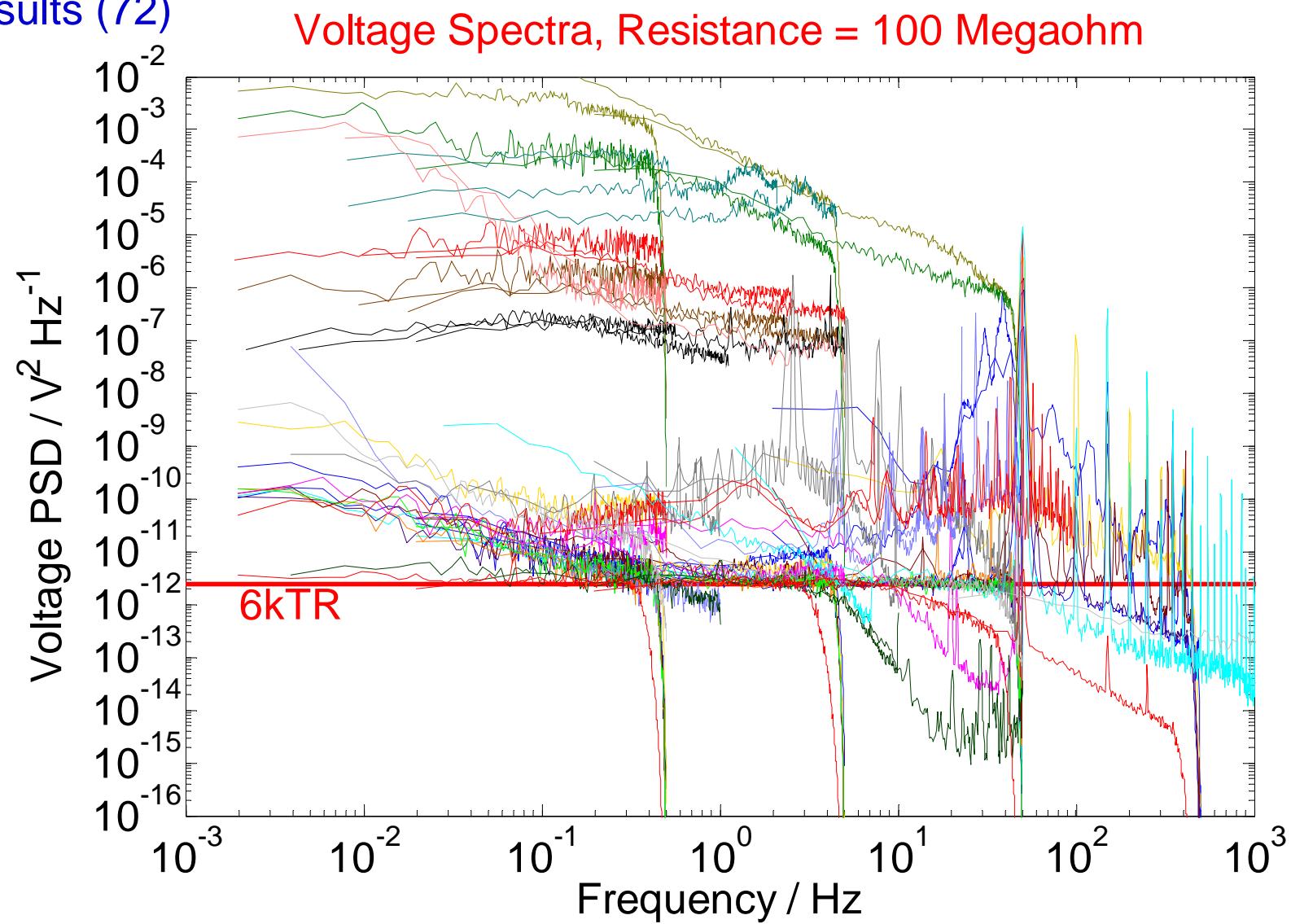
All results (99)



large scatter: not better than PSD measured in 2014

## Part 3 – RR12 – 2017: analysis of the voltage PSDs ( $R = 100 \text{ M}\Omega$ )

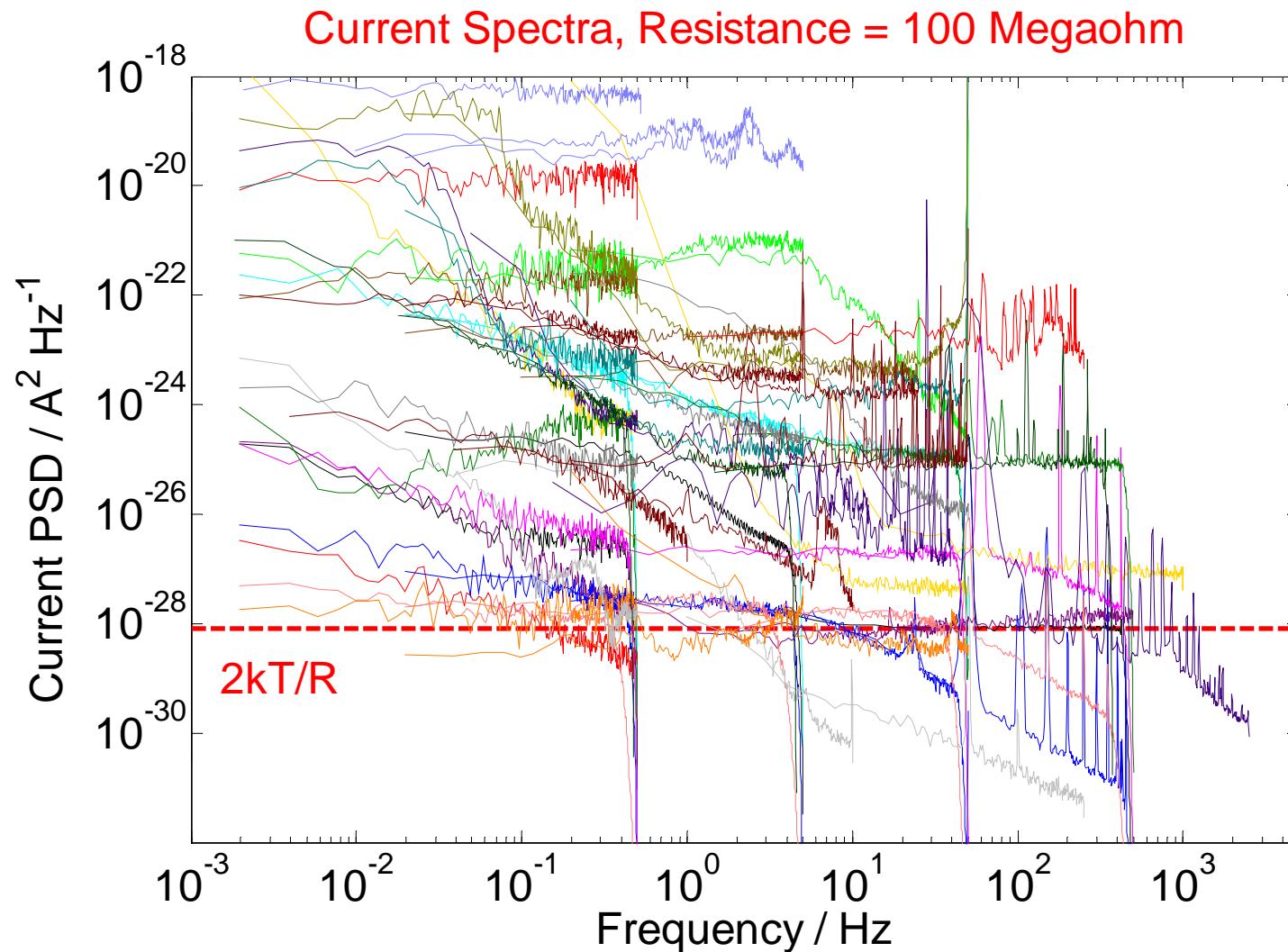
All results (72)



large scatter: not better than PSD measured in 2016

## Part 4 – RR8 – 2014: analysis of the current PSDs ( $R = 100 \text{ M}\Omega$ )

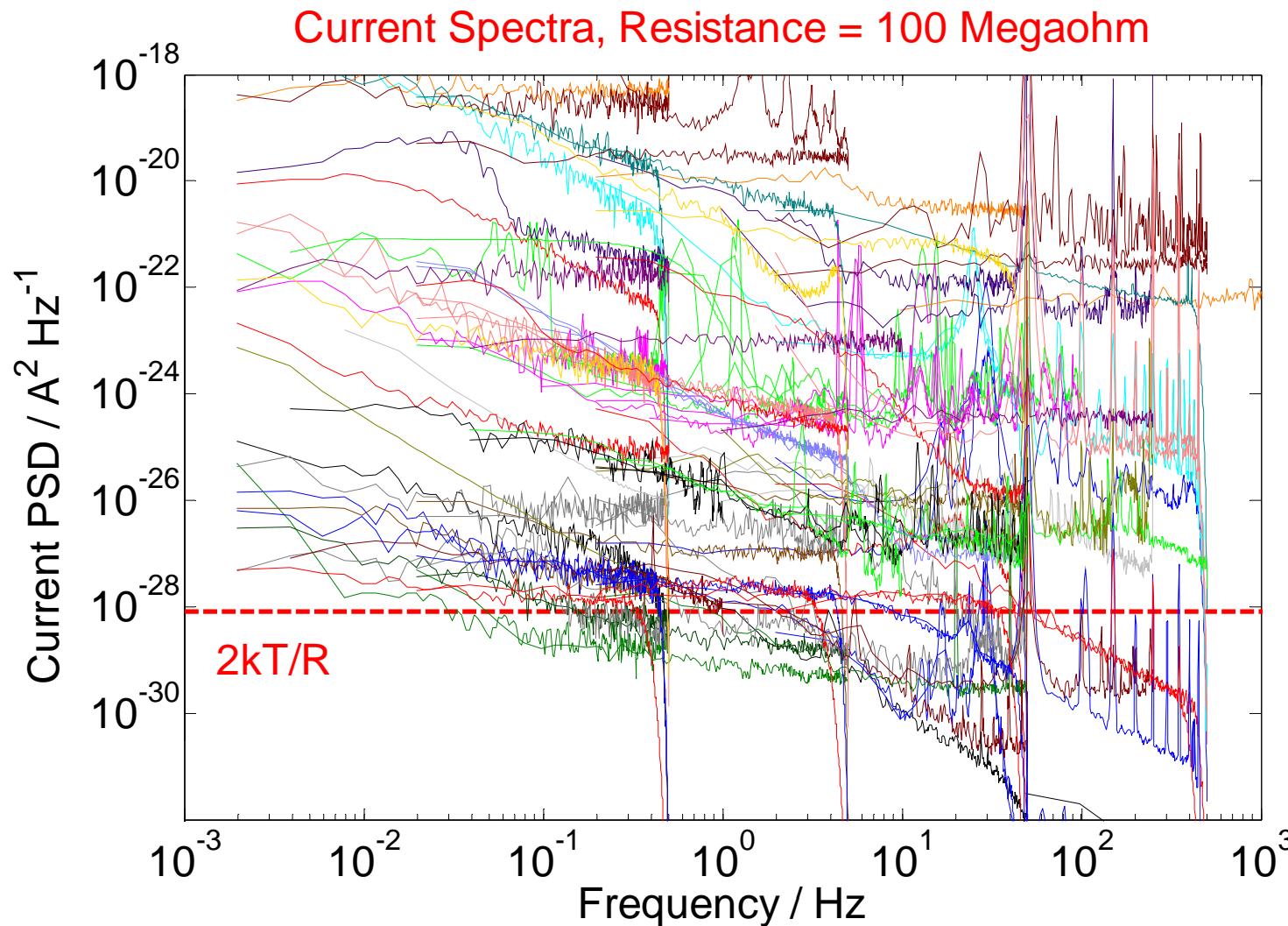
All results but 3 (66)



large scatter but the current noise PSD is low

## Part 4 – RR11 – 2016: analysis of the current PSDs ( $R = 100 \text{ M}\Omega$ )

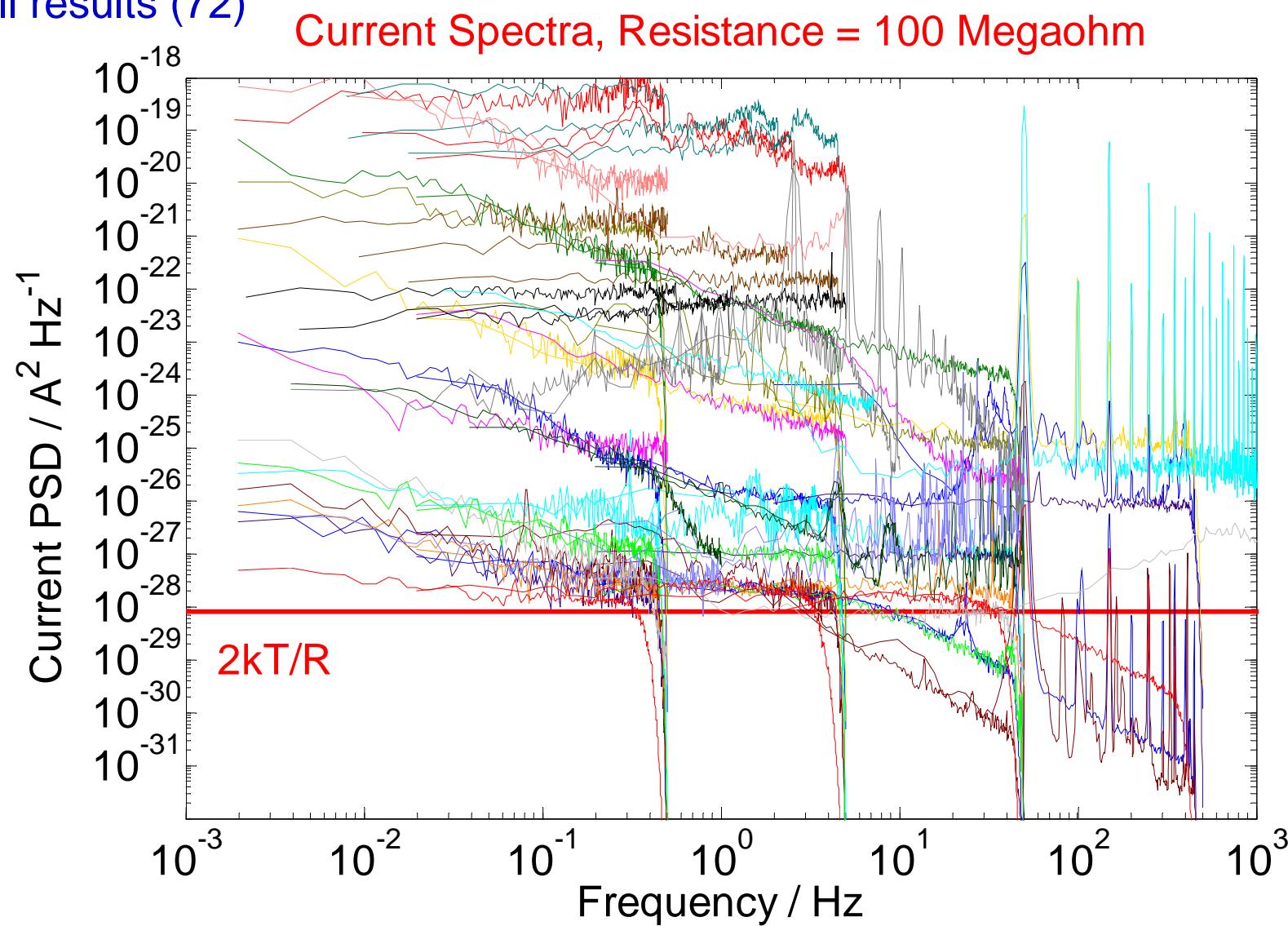
All results (99)



large scatter: not better than PSD measured in 2014

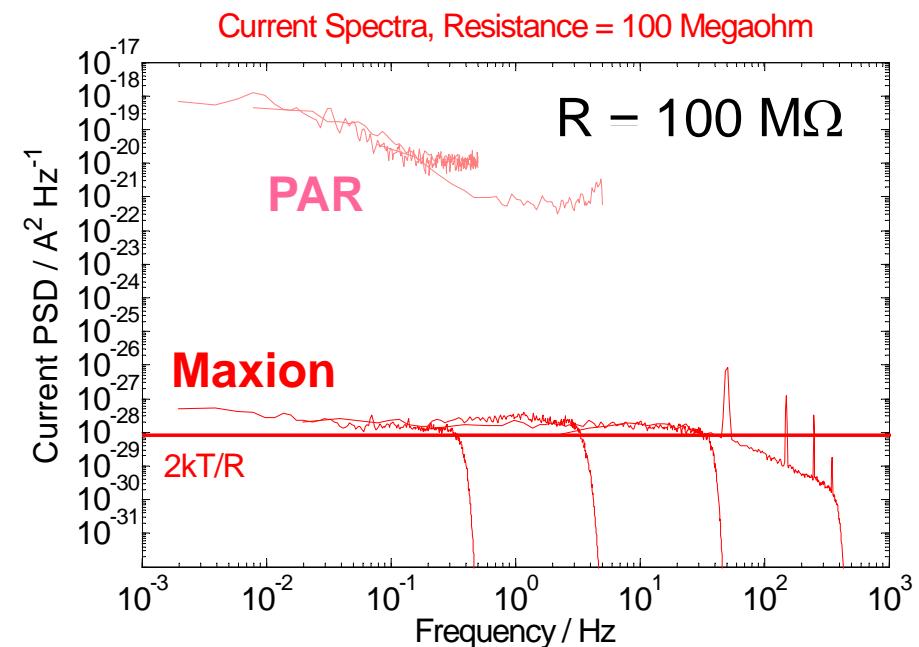
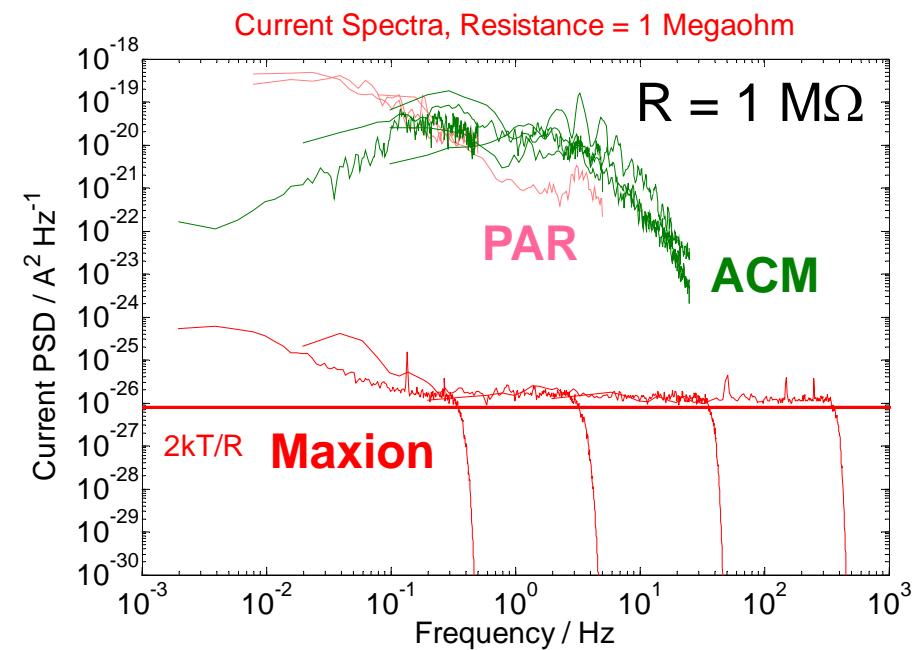
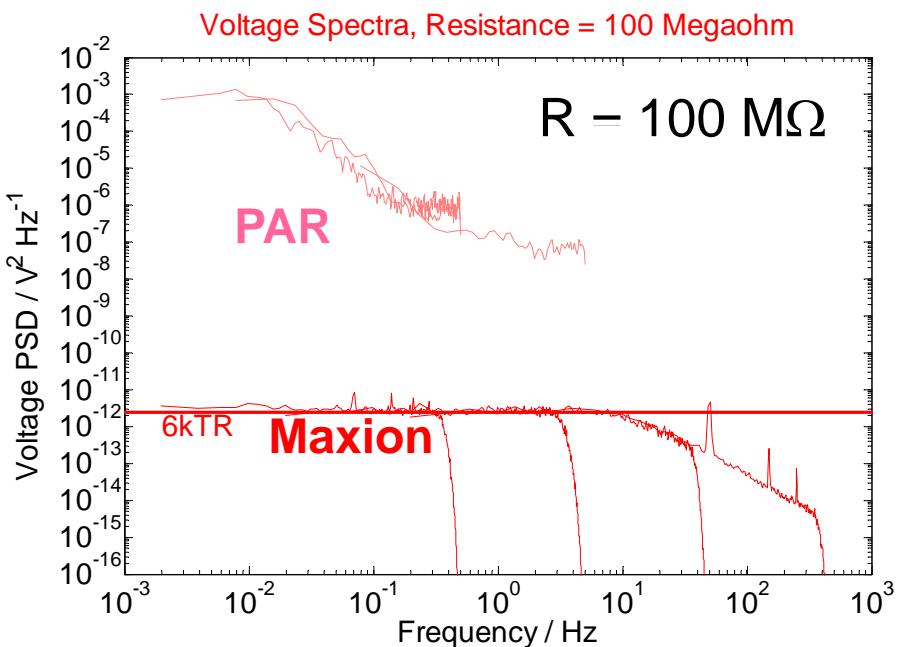
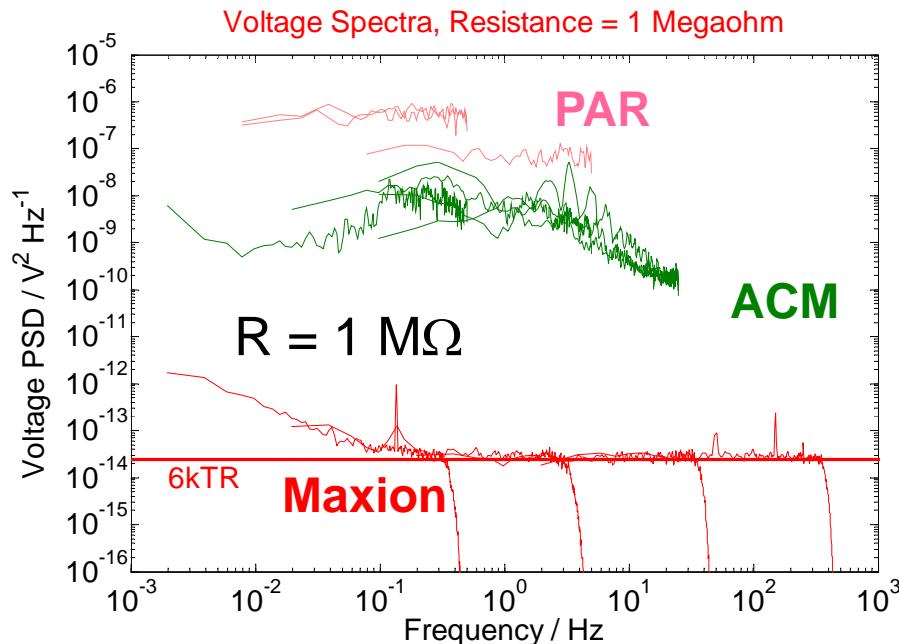
## Part 4 – RR12 – 2017: analysis of the current PSDs ( $R = 100 \text{ M}\Omega$ )

All results (72)

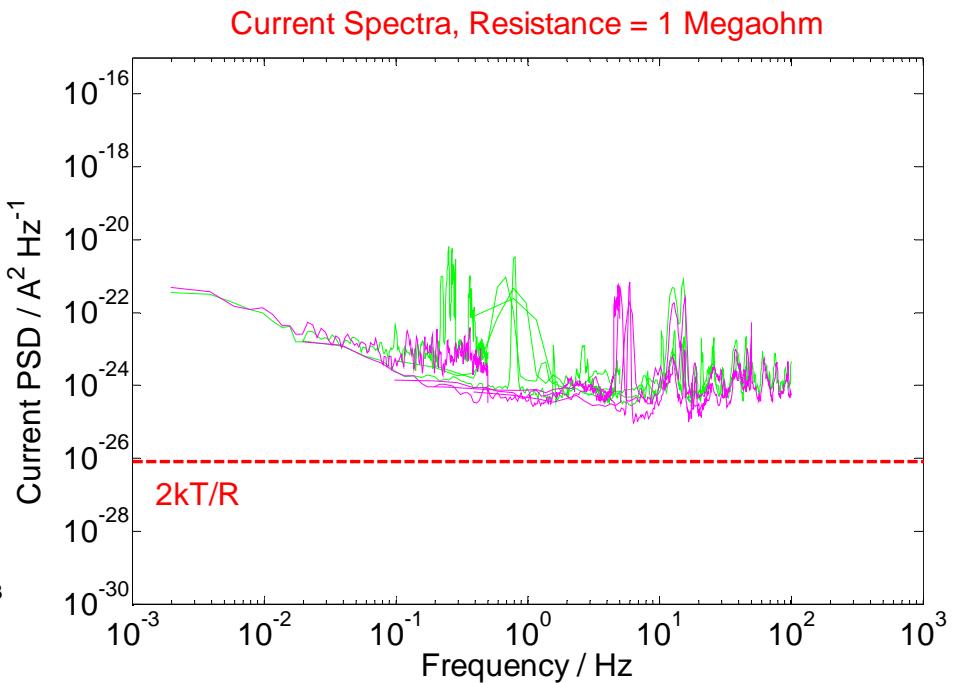
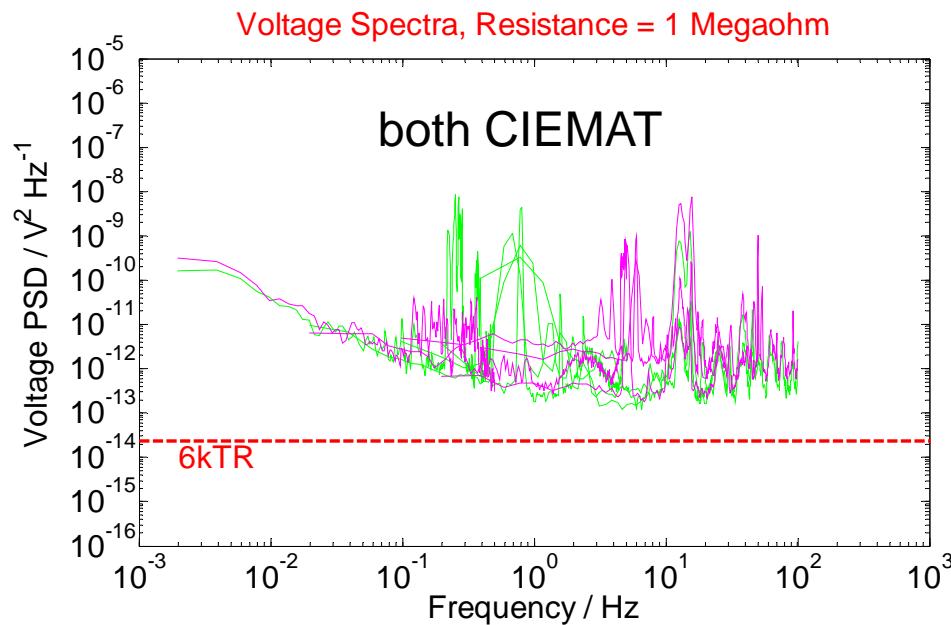


large scatter: not better than PSD measured in 2016

# PAR, ACM, Maxion results for $R = 1 \text{ M}\Omega$ and $100 \text{ M}\Omega$ (RR12 – 2017)

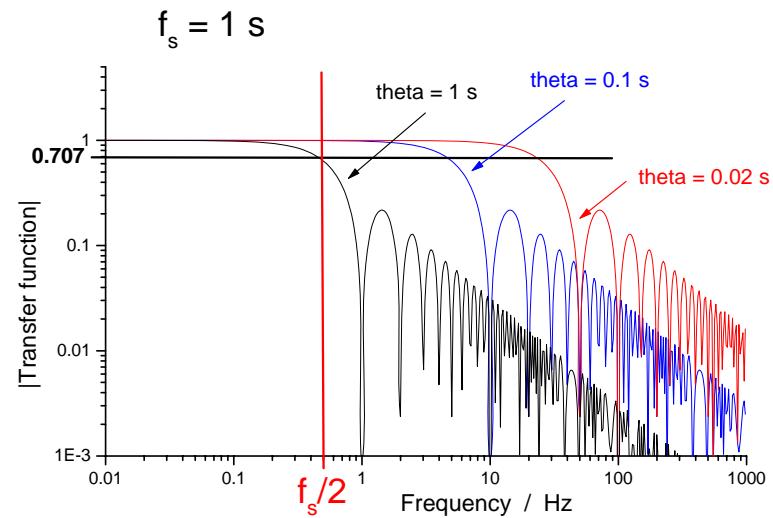


# Solartron results for $R = 1 \text{ M}\Omega$ (RR11 – 2016)

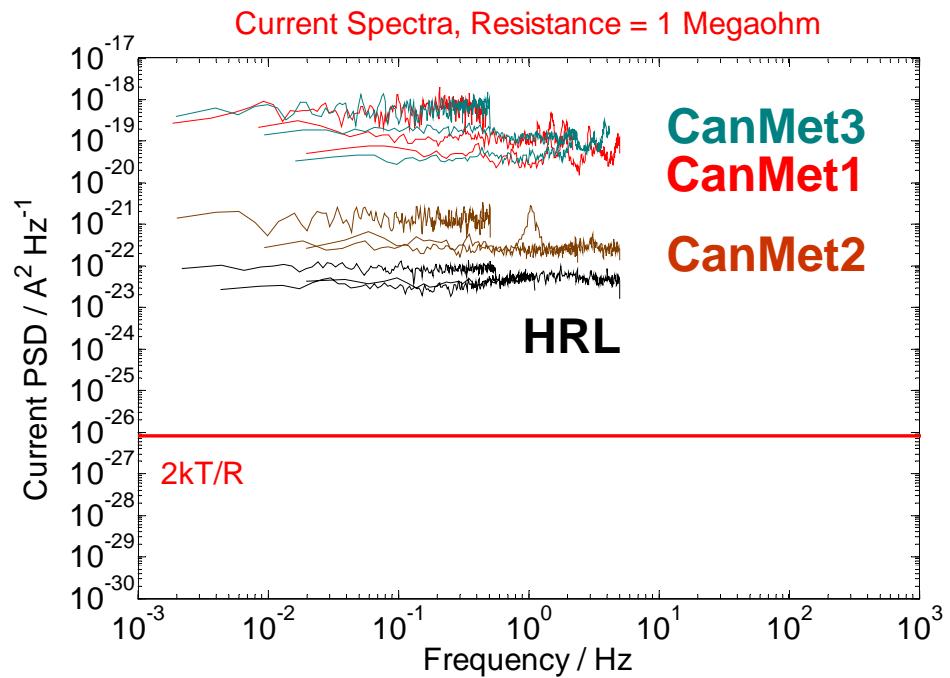
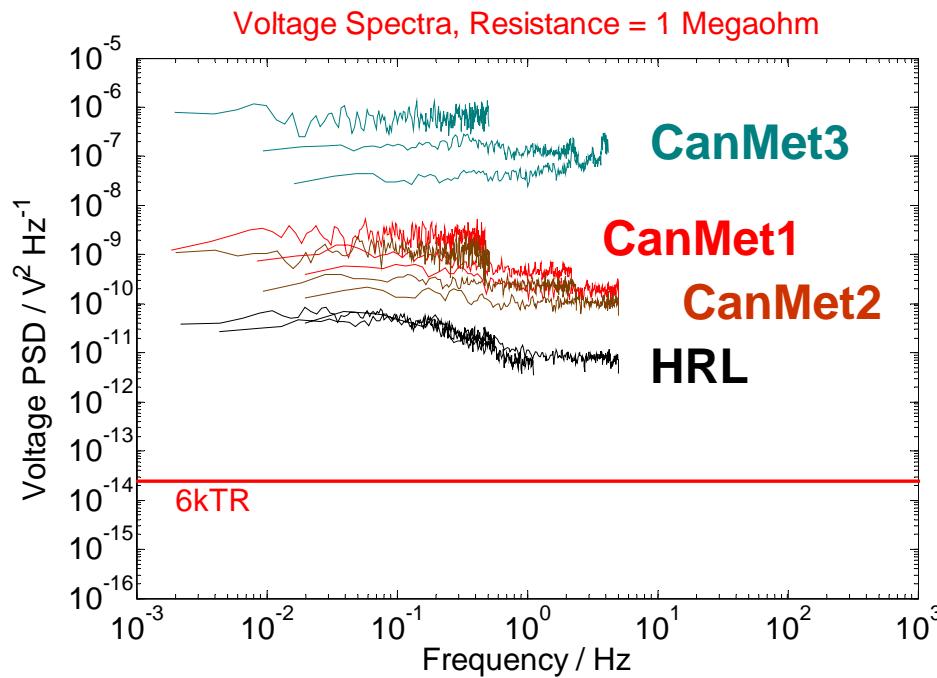


Anti-aliasing filtering by integration  
of the analog signal during time  $1 / f_s$   
like in digital voltmeters

→ not efficient for eliminating  
aliasing of 50 Hz and  
harmonics

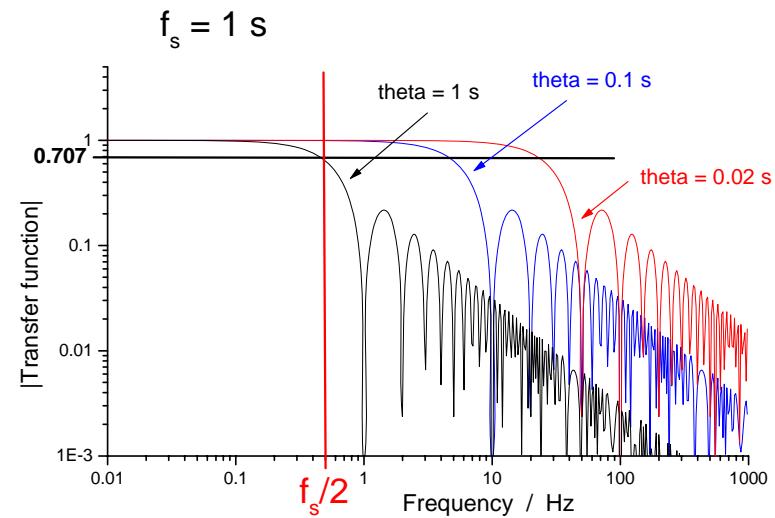


# Solartron results for $R = 1 \text{ M}\Omega$ (RR12 – 2017)

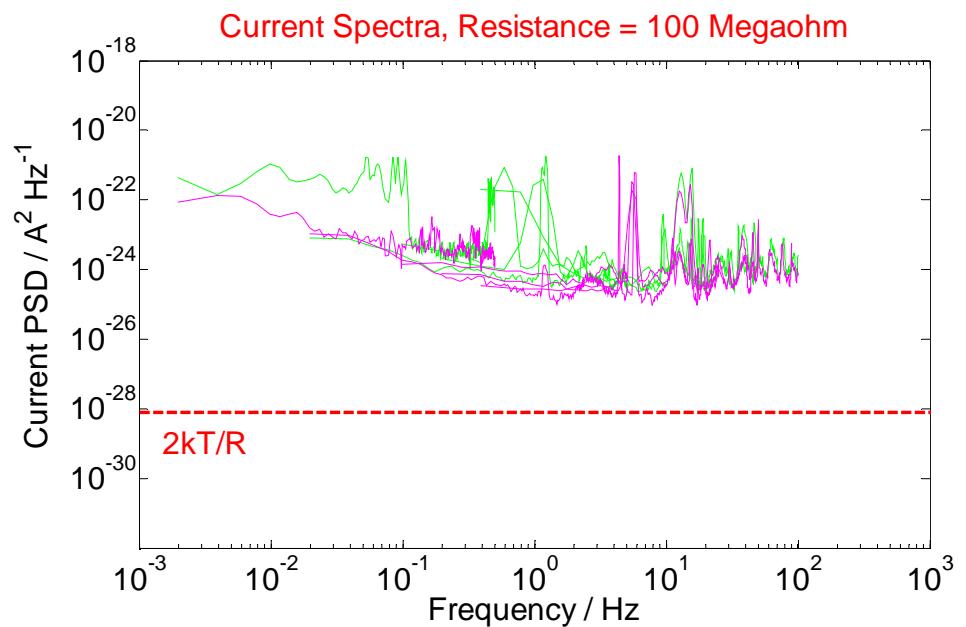
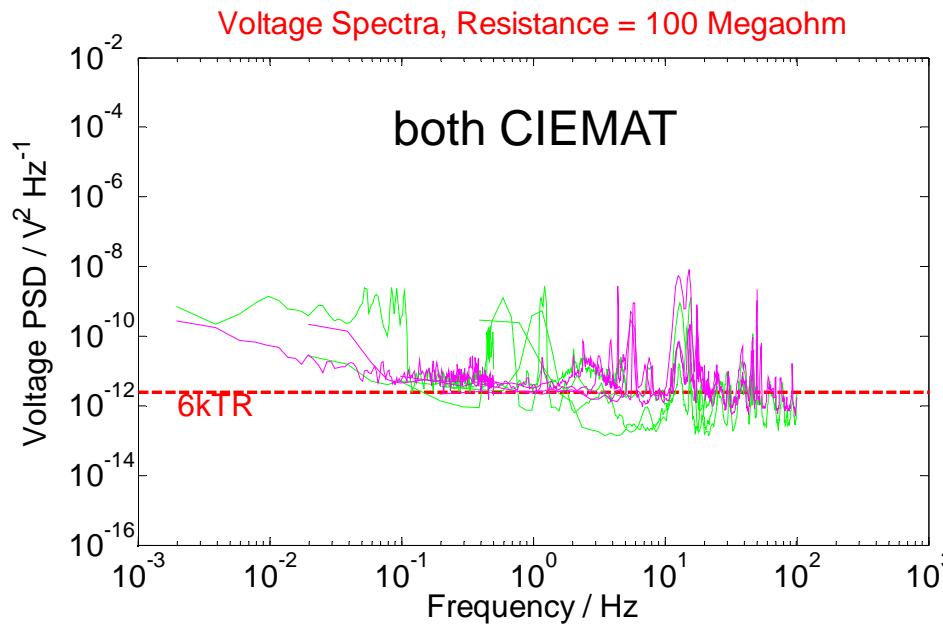


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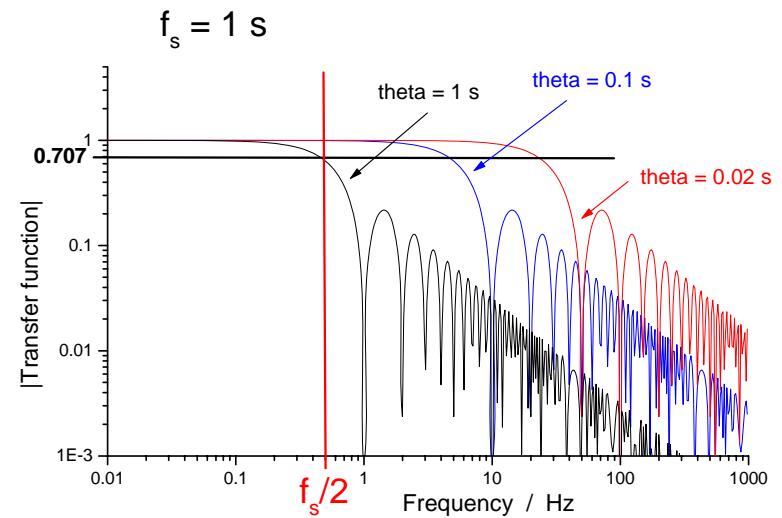


# Solartron results for $R = 100 \text{ M}\Omega$ (RR11 – 2016)

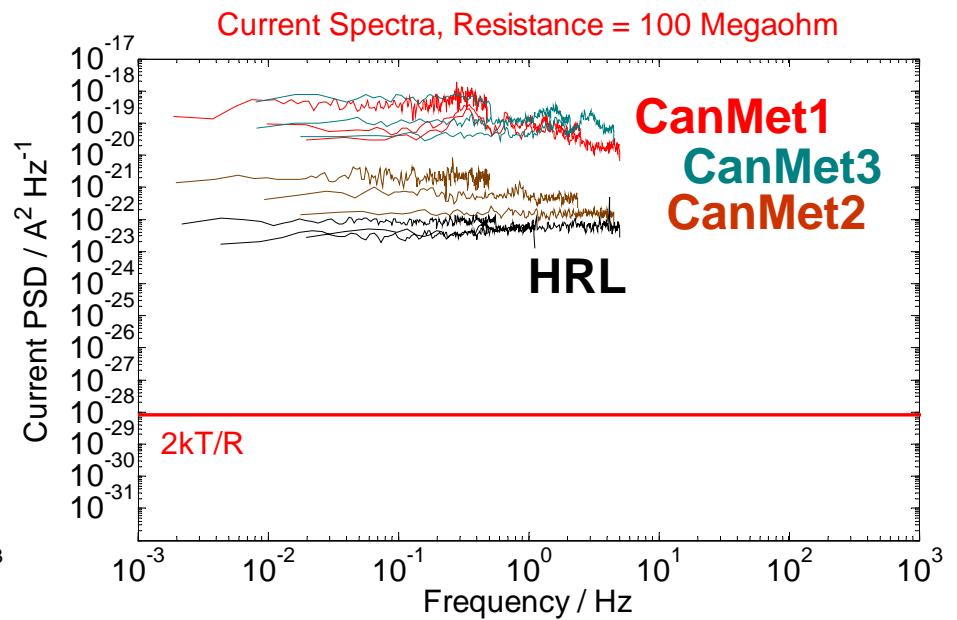
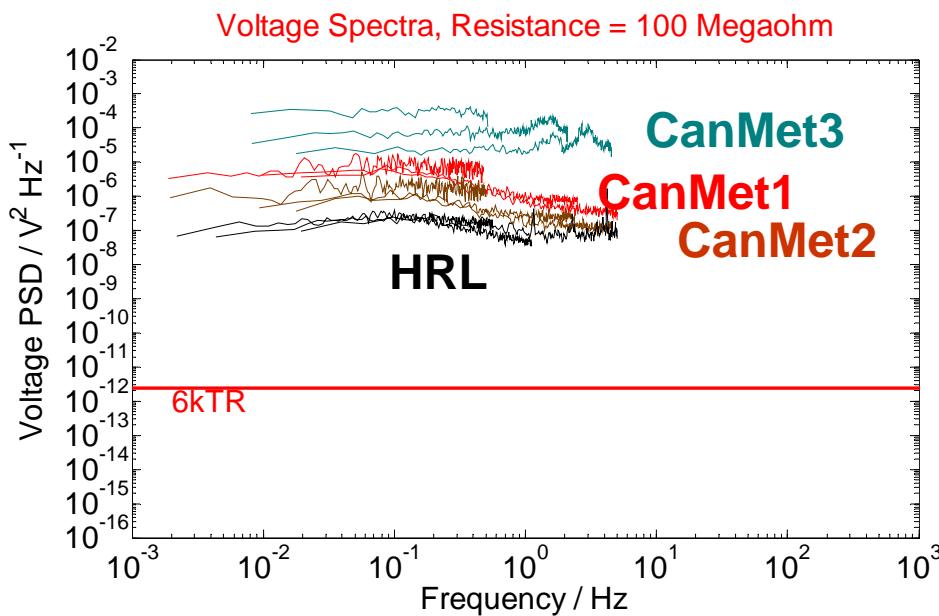


Anti-aliasing filtering by integration  
of the analog signal during time  $1 / f_s$   
like in digital voltmeters

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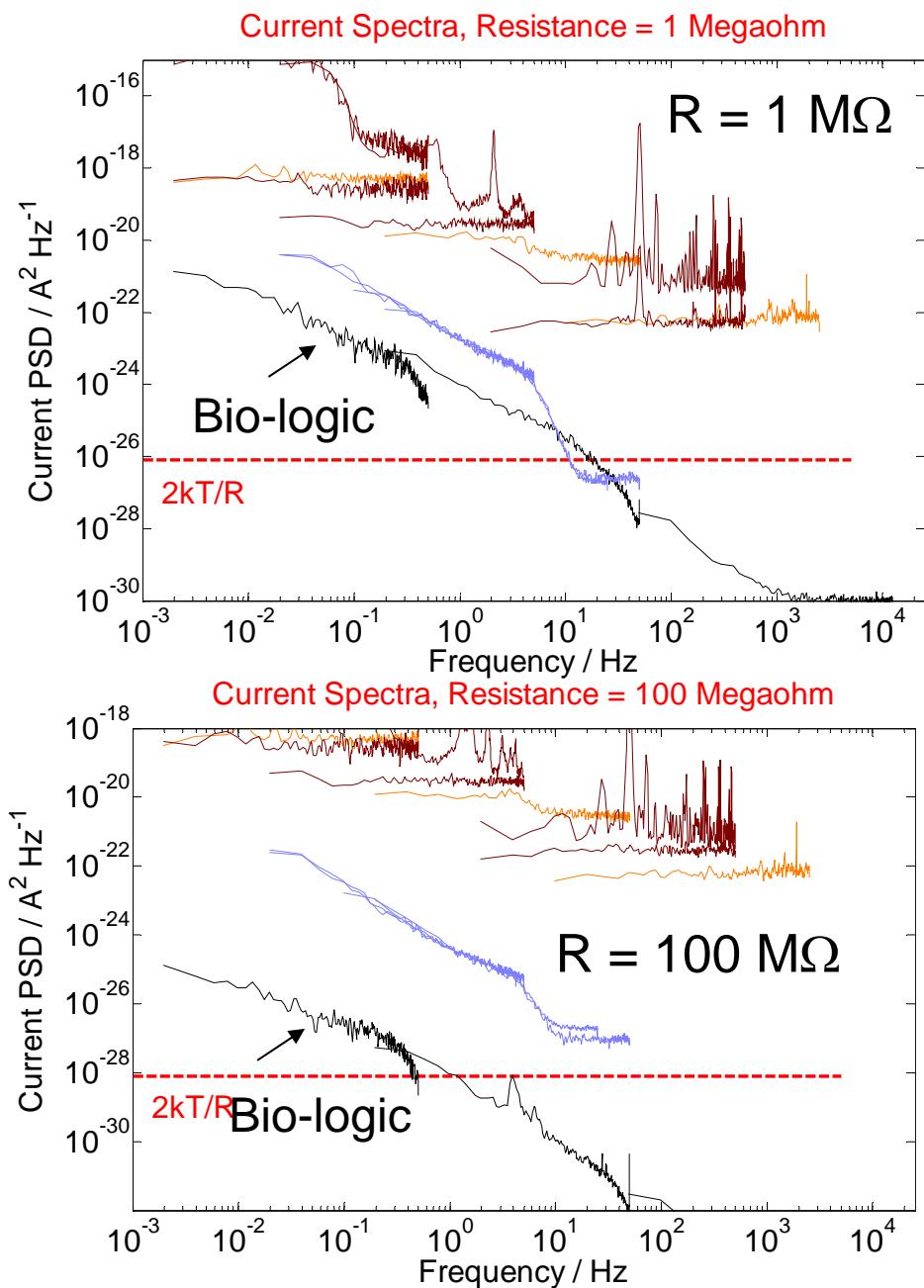
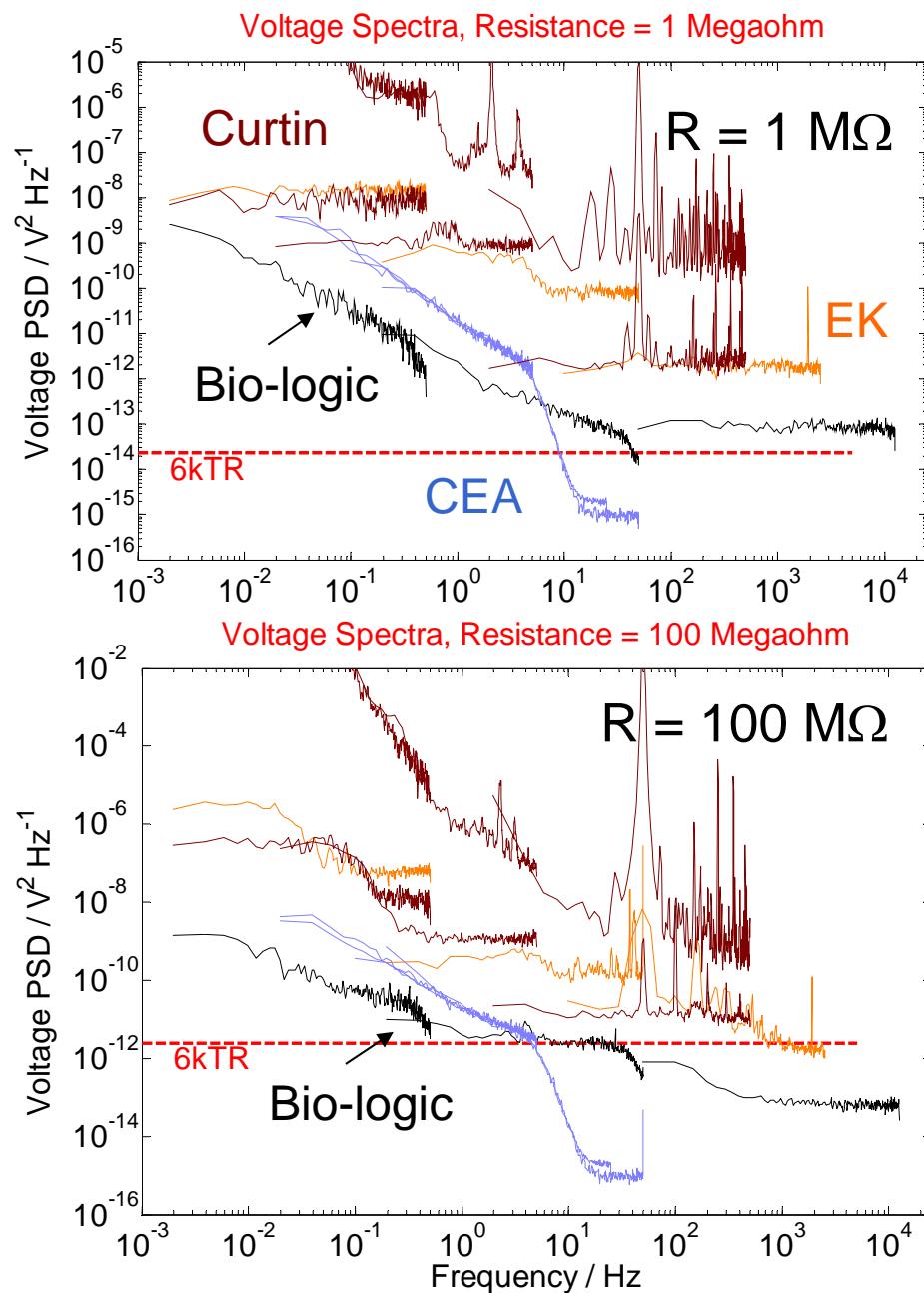
## Solartron results for $R = 100 \text{ M}\Omega$ (RR12 – 2017)



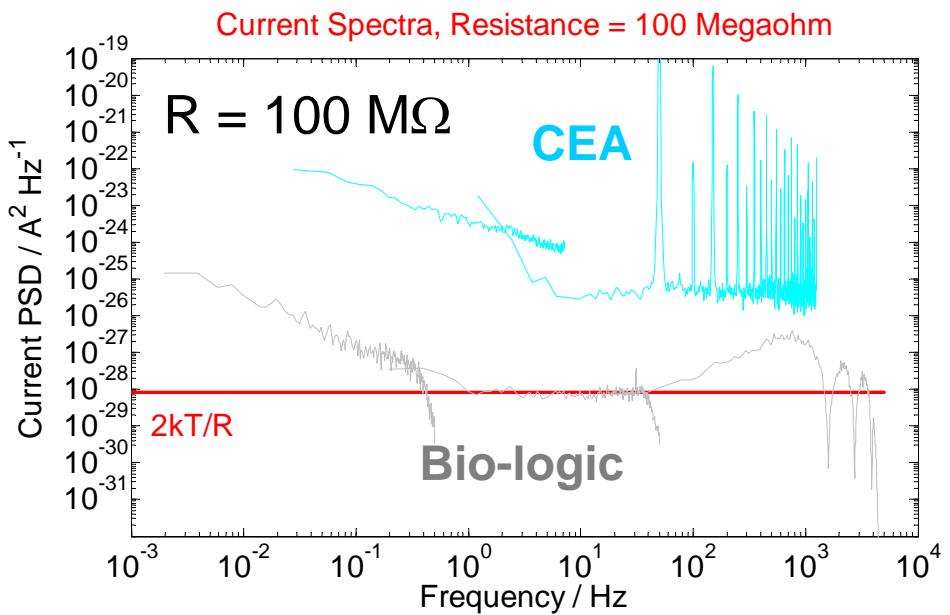
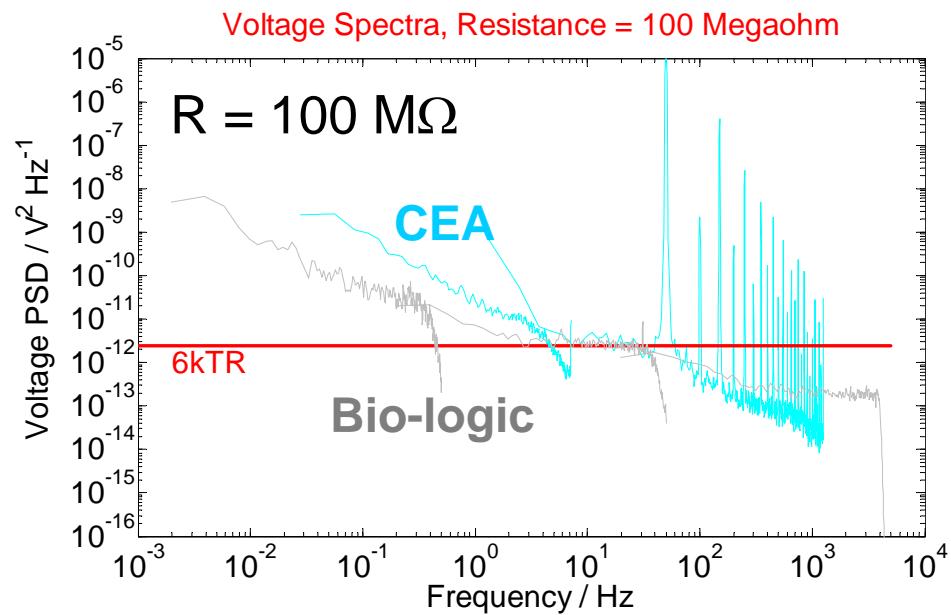
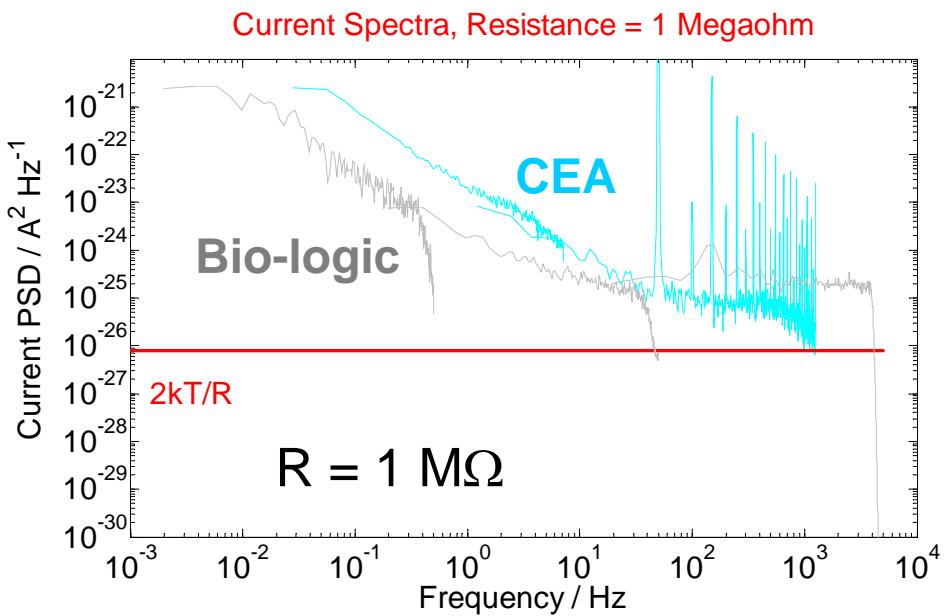
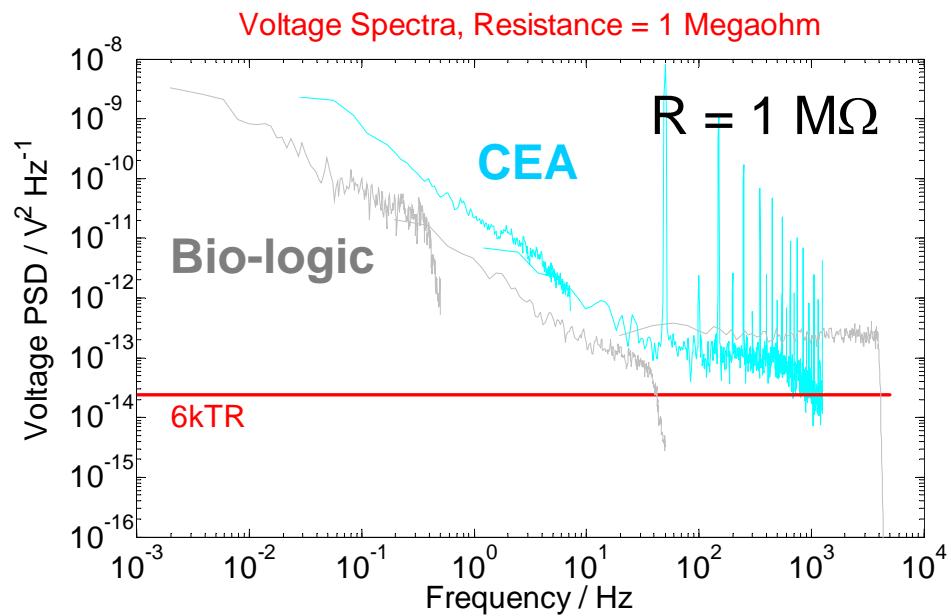
for Solarton 1287:

- Anti-aliasing filtering exists (integration of the analog signal during time  $1 / f_s$ )
- not efficient for eliminating aliasing of 50 Hz and harmonics
- the user has to be trained to use it correctly

# Bio-logic results for $R = 1 \text{ M}\Omega$ and $100 \text{ M}\Omega$ (RR11 – 2016)

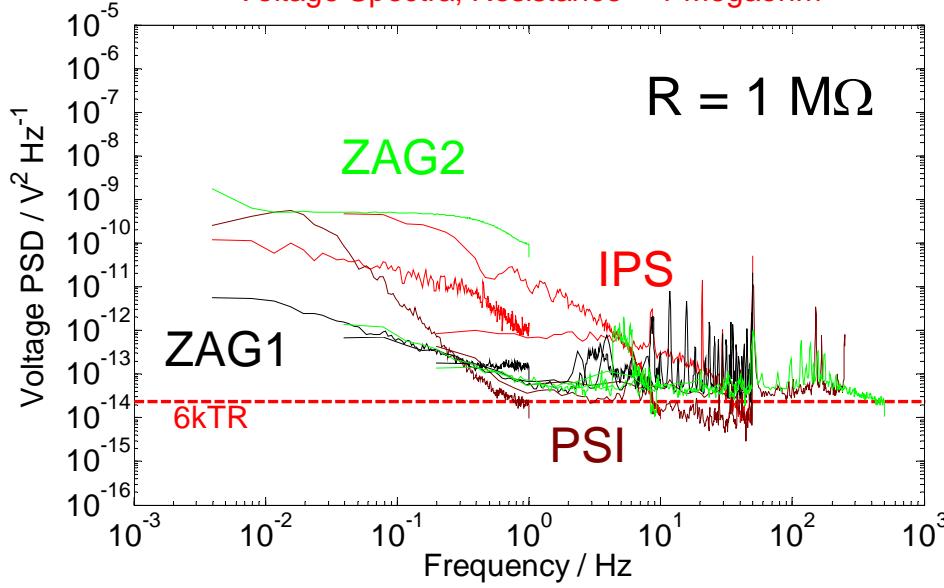


# Bio-logic results for $R = 1 \text{ M}\Omega$ and $100 \text{ M}\Omega$ (RR12 – 2017)

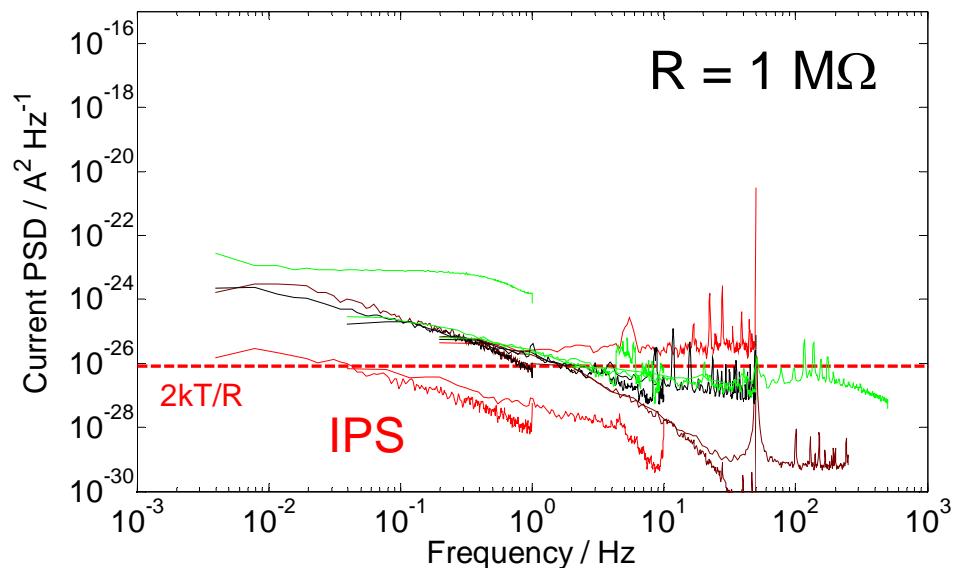


# IPS results for $R = 1 \text{ M}\Omega$ and $100 \text{ M}\Omega$ (RR11 – 2016)

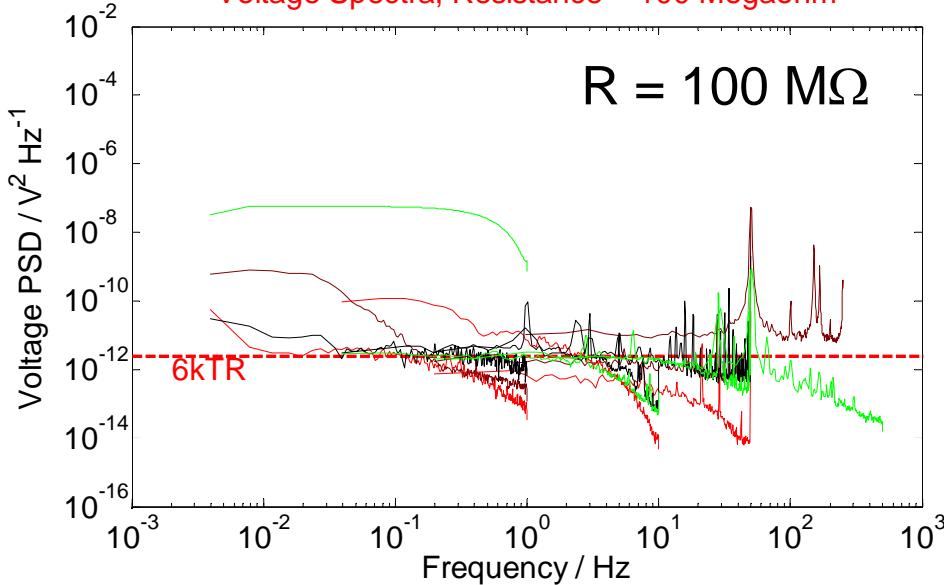
Voltage Spectra, Resistance = 1 Megaohm



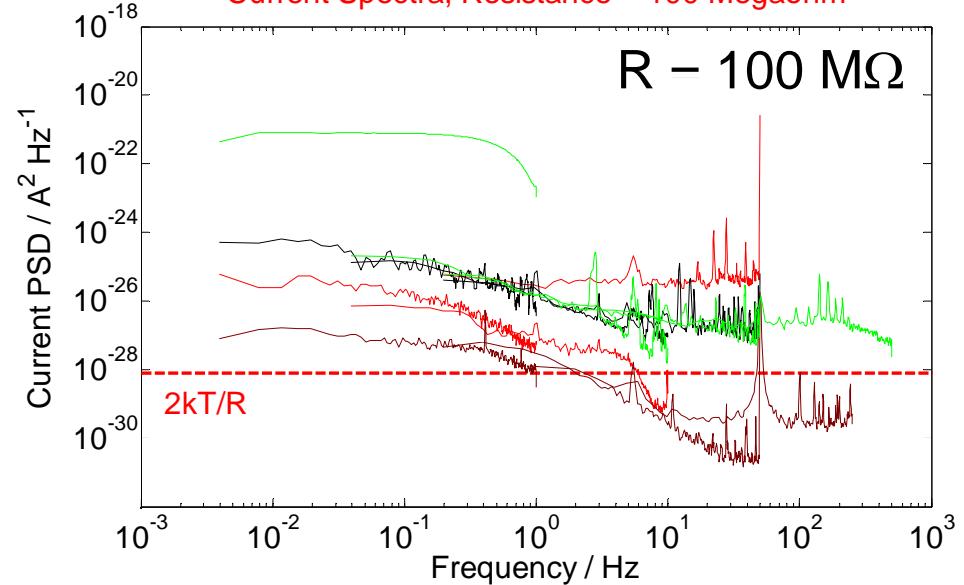
Current Spectra, Resistance = 1 Megaohm



Voltage Spectra, Resistance = 100 Megaohm

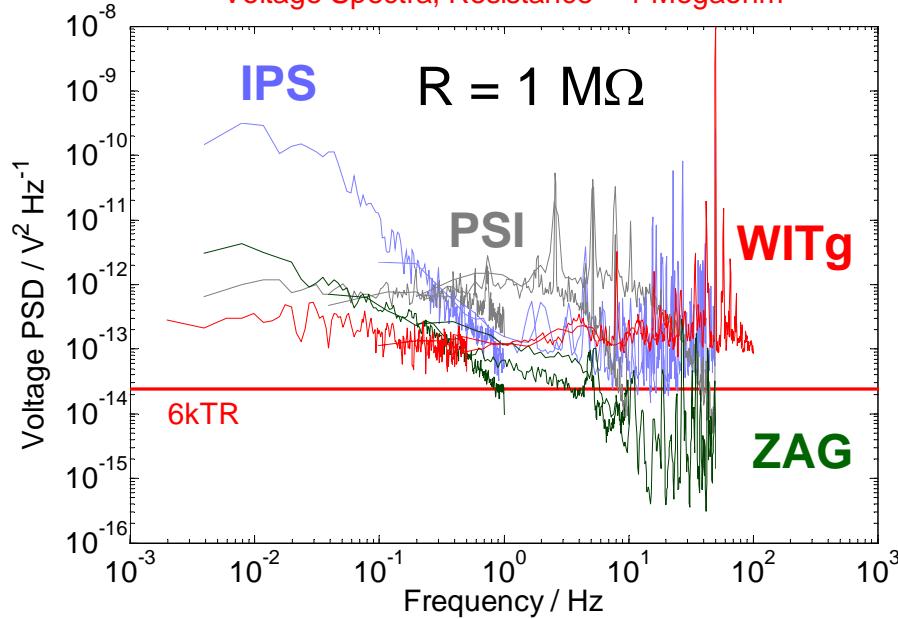


Current Spectra, Resistance = 100 Megaohm

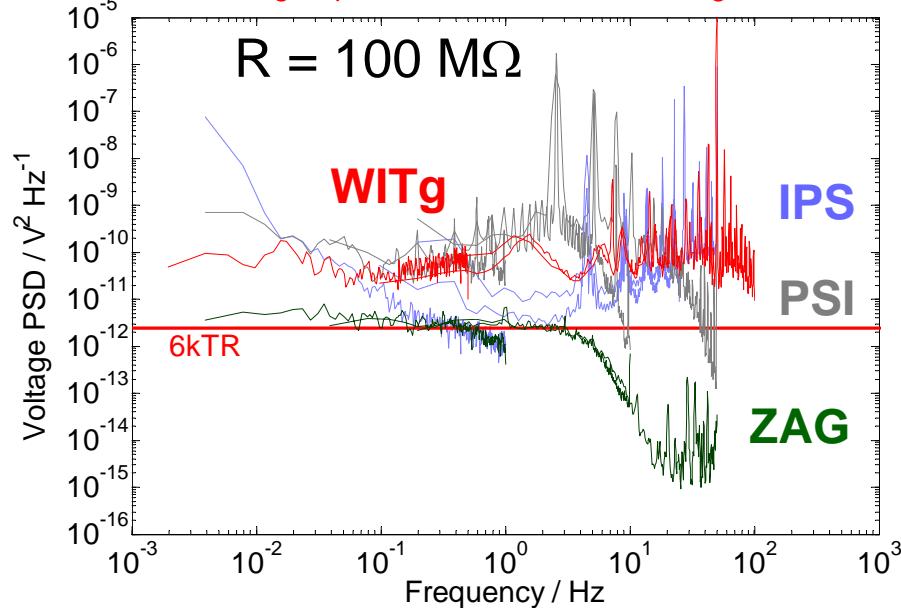


# IPS results for $R = 1 \text{ M}\Omega$ and $100 \text{ M}\Omega$ (RR12 – 2017)

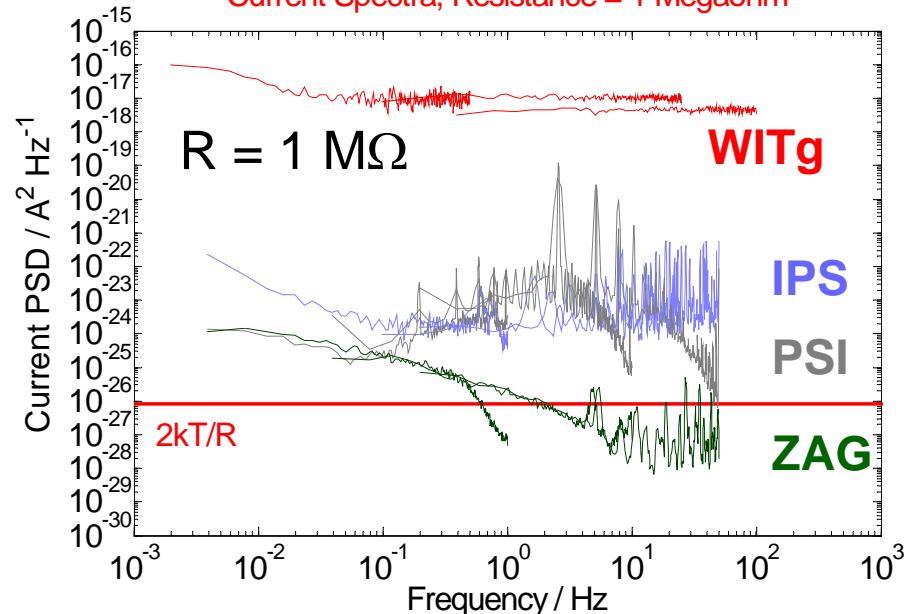
Voltage Spectra, Resistance = 1 Megaohm



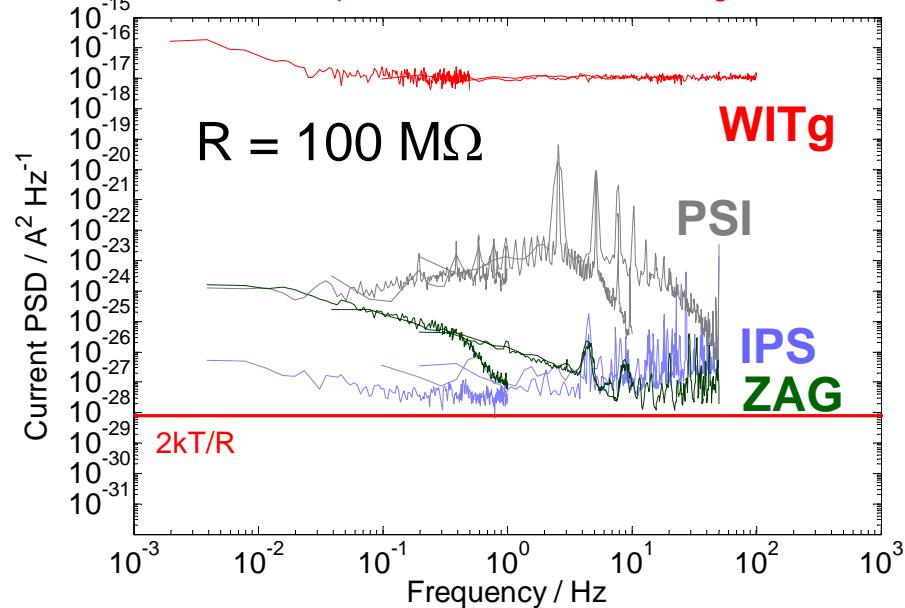
Voltage Spectra, Resistance = 100 Megaohm



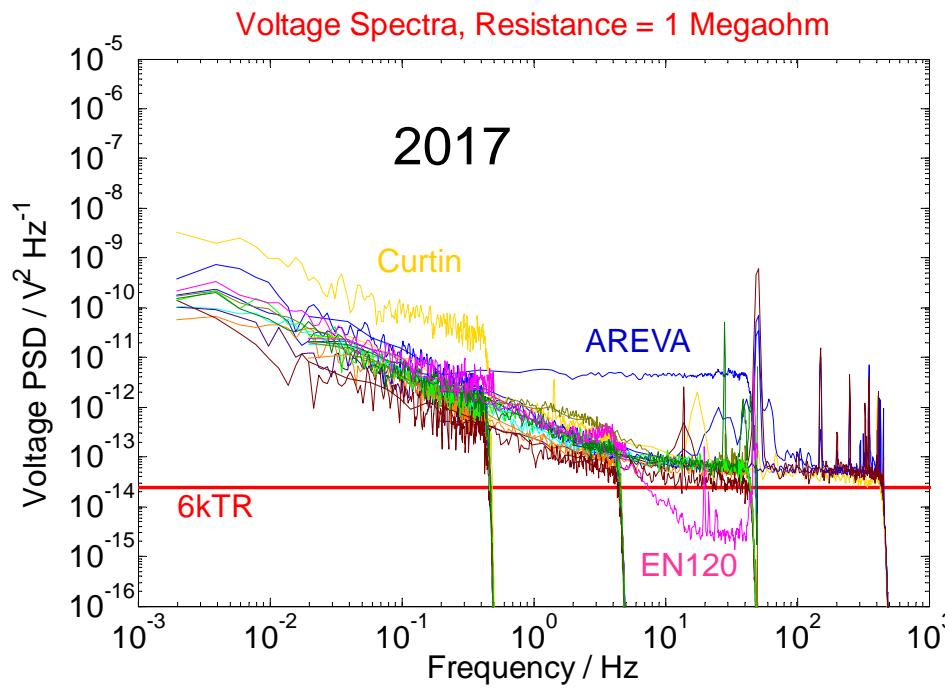
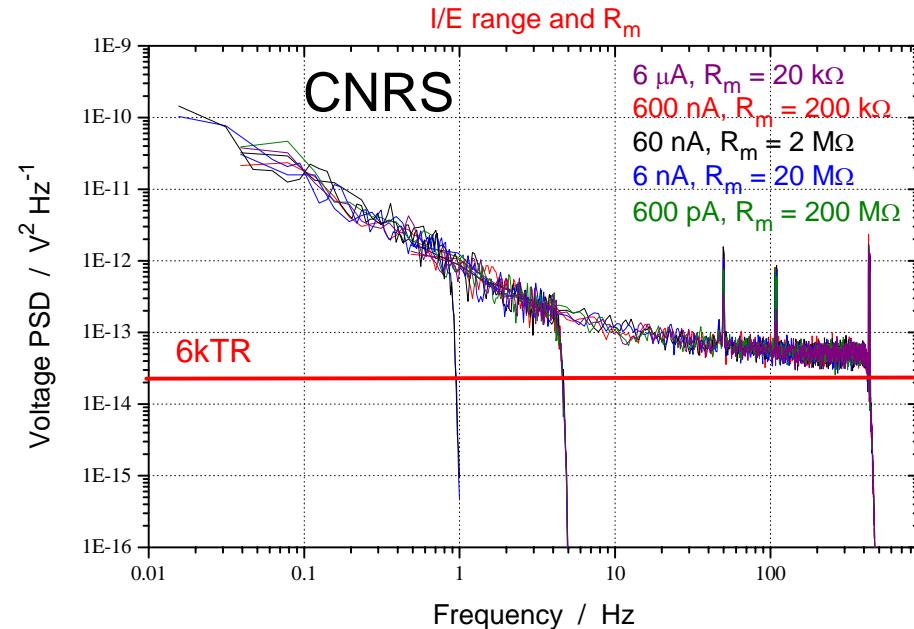
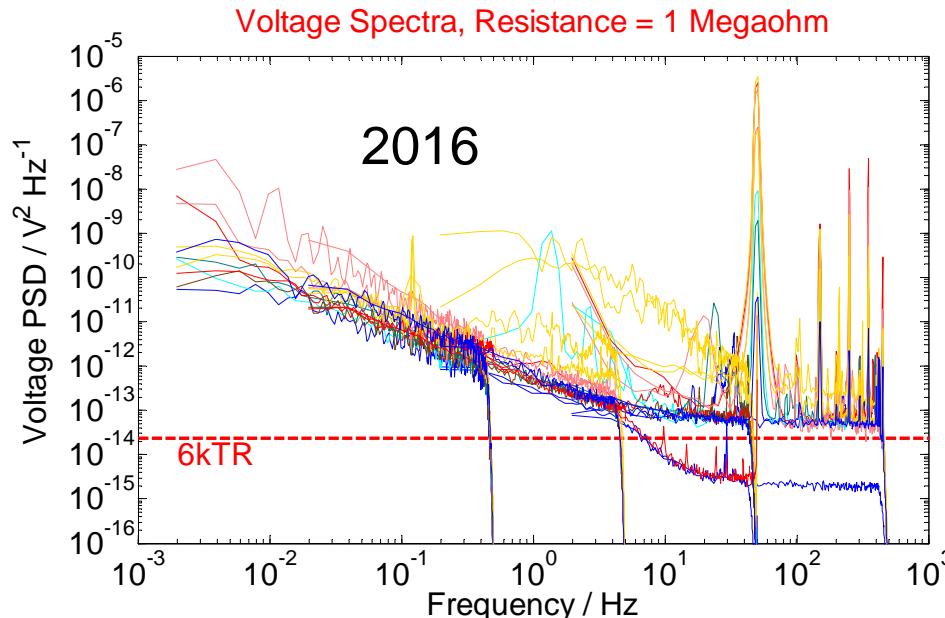
Current Spectra, Resistance = 1 Megaohm



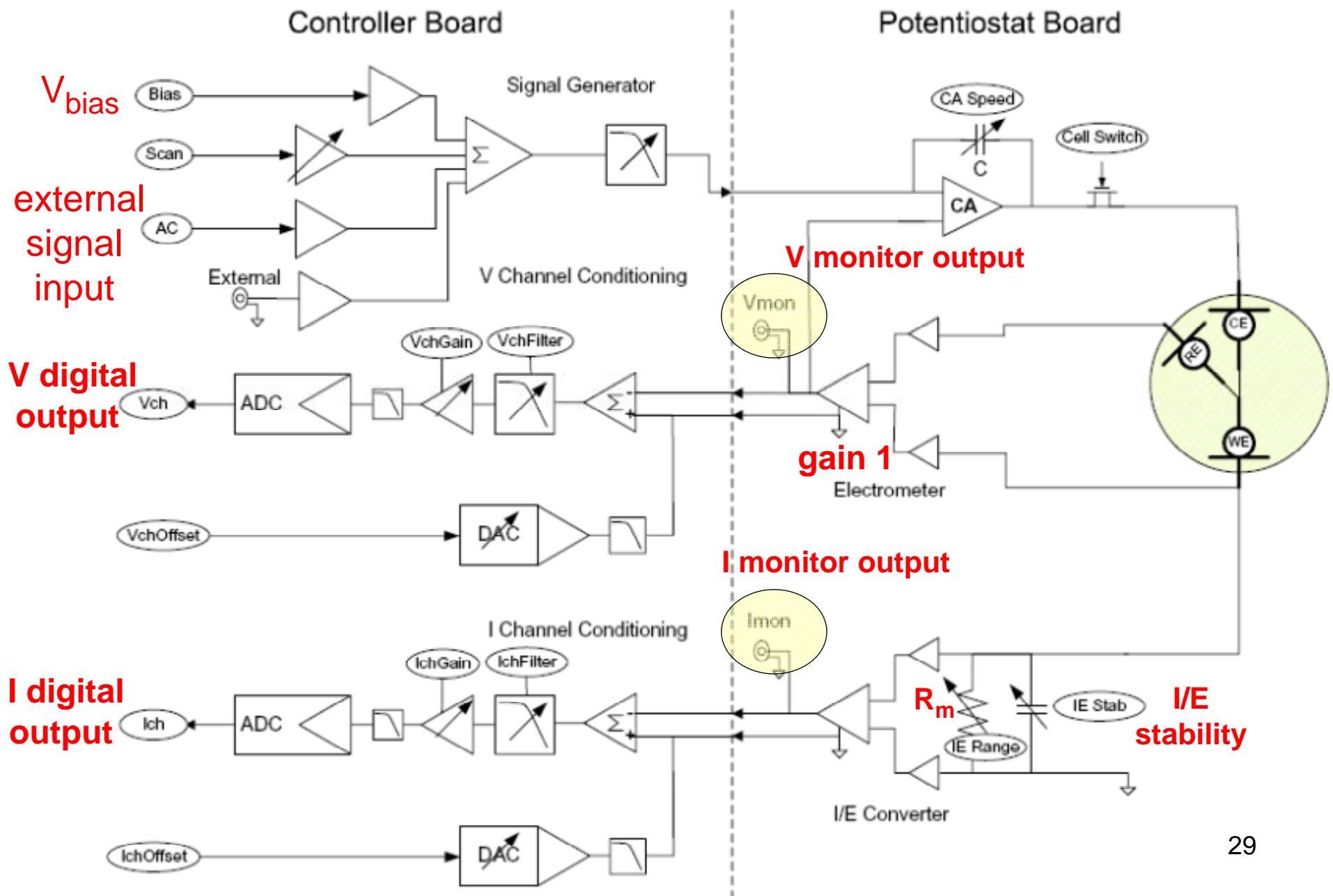
Current Spectra, Resistance = 100 Megaohm



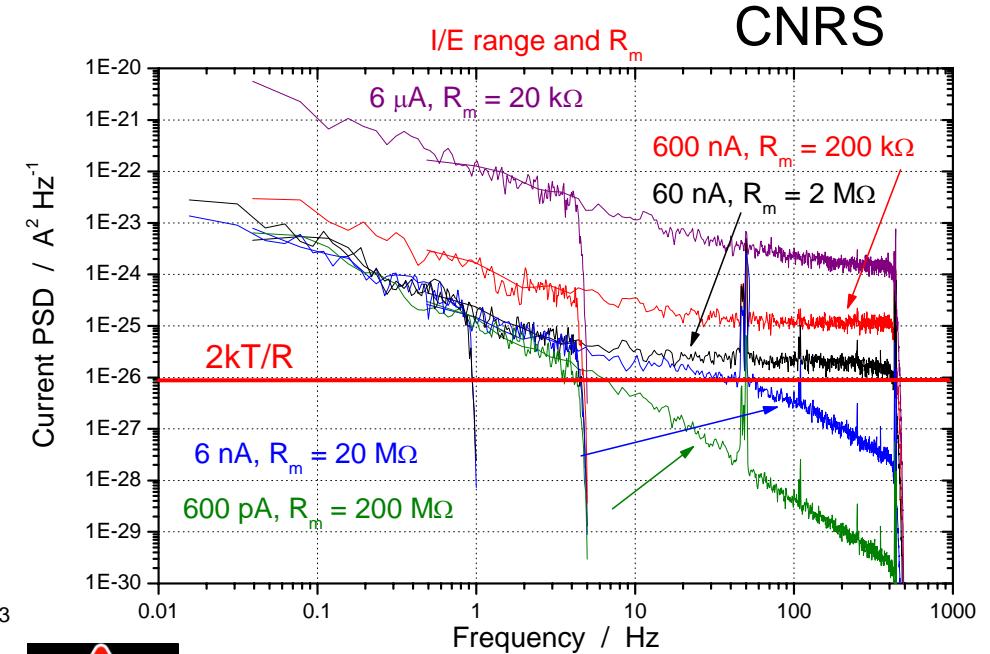
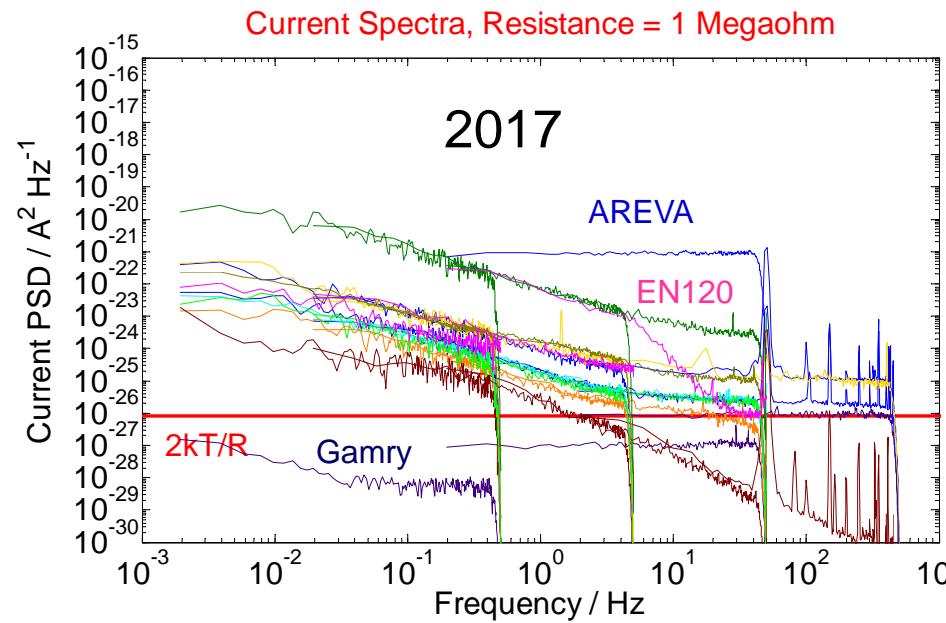
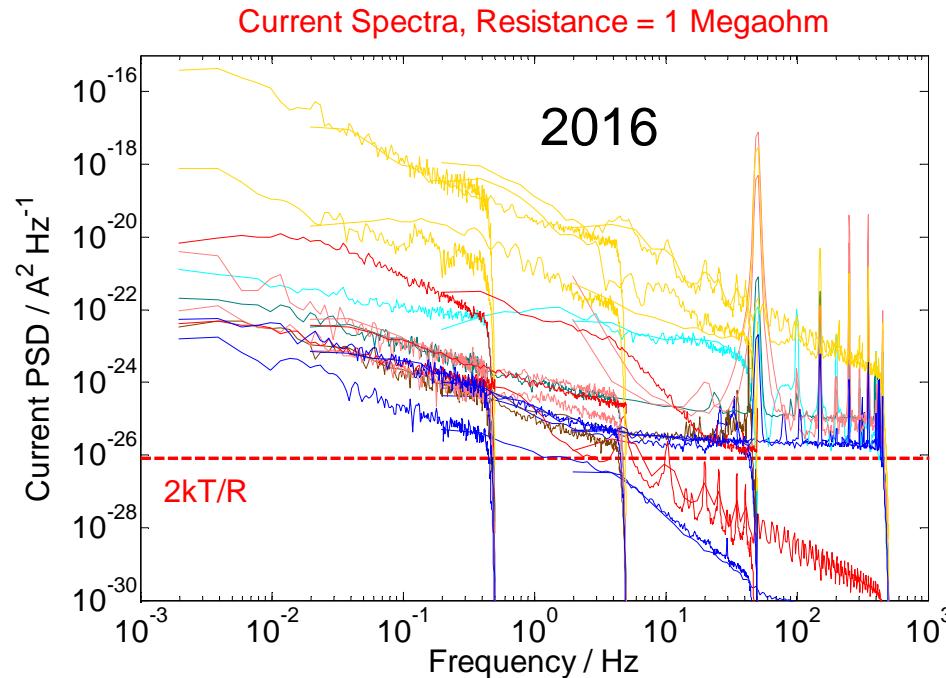
# Gamry results for $R = 1 \text{ M}\Omega$ : voltage



# Ref 600 analog circuit



## Gamry results for $R = 1 \text{ M}\Omega$ : current

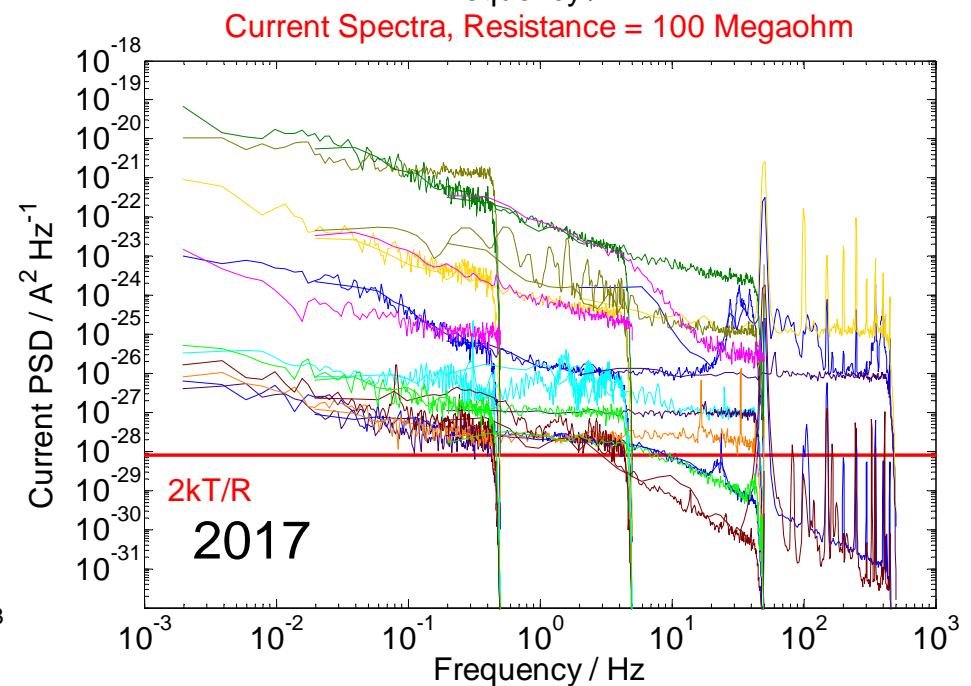
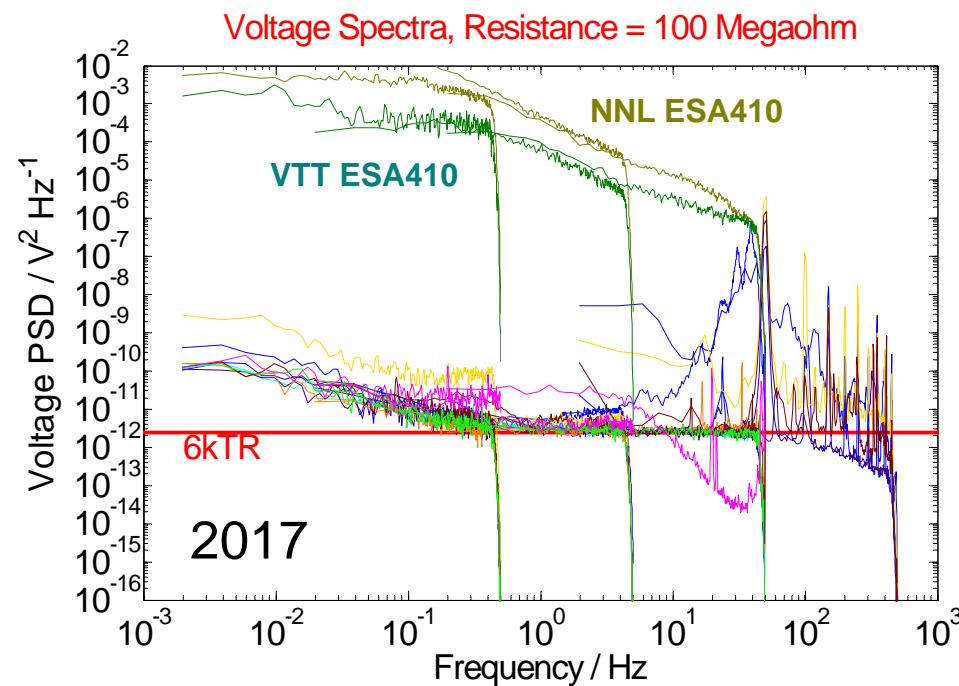
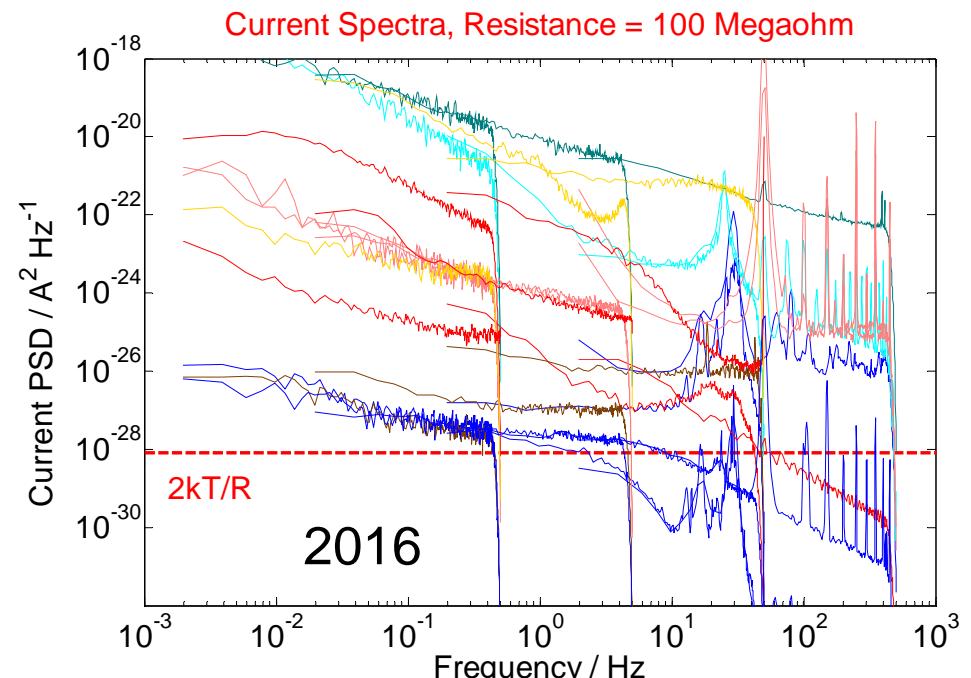
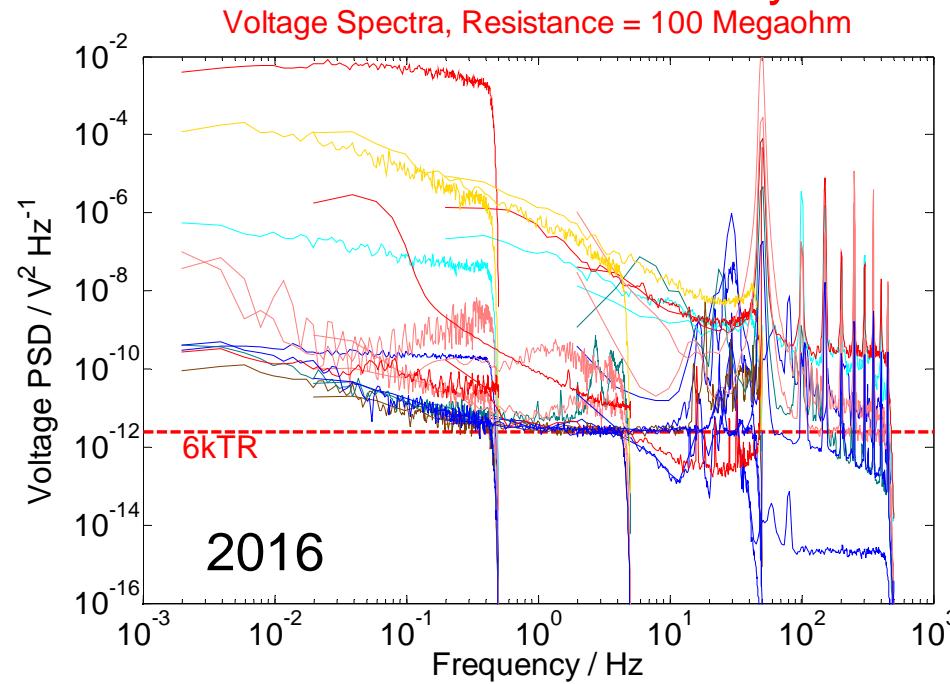


increasing the sensitivity ( $I/E$  range)  
decrease the frequency bandwidth

For  $I/E$  stability **fast**:  $C = 150 \text{ pF}$

$I/E$ range	$R_m$	$f_c$
6 $\mu\text{A}$	20 $\text{k}\Omega$	50 kHz
600 nA	200 $\text{k}\Omega$	5 kHz
60 nA	2 $\text{M}\Omega$	500 Hz
6 nA	20 $\text{M}\Omega$	50 Hz
600 pA	200 $\text{M}\Omega$	5 Hz

# Gamry results for $R = 100 \text{ M}\Omega$



## Conclusions on RR #12

- new EN RR test on dummy cells with 24 data sets including 3 from manufacturers
- still large scatter in the PSDs, especially the current PSDs
- good PSD measurements (= good PSD overlaps) for only a few commercial equipments (Gamry with ESA-410, Bio-logic?, IPS?)
- even with good equipments, data provided by common users are often wrong: they do not set the right parameters in the setup for ENM
  - what can be done? organisation of training course ?
- the manufacturers should provide:
  - improved software (no access to filters, no conflicting choice of  $f_s$  and I/E range limiting the frequency bandwidth...)
  - a tutorial for ENM with dummy cells

## Procedure of EN measurement (Gamry Ref600 and ESA410)

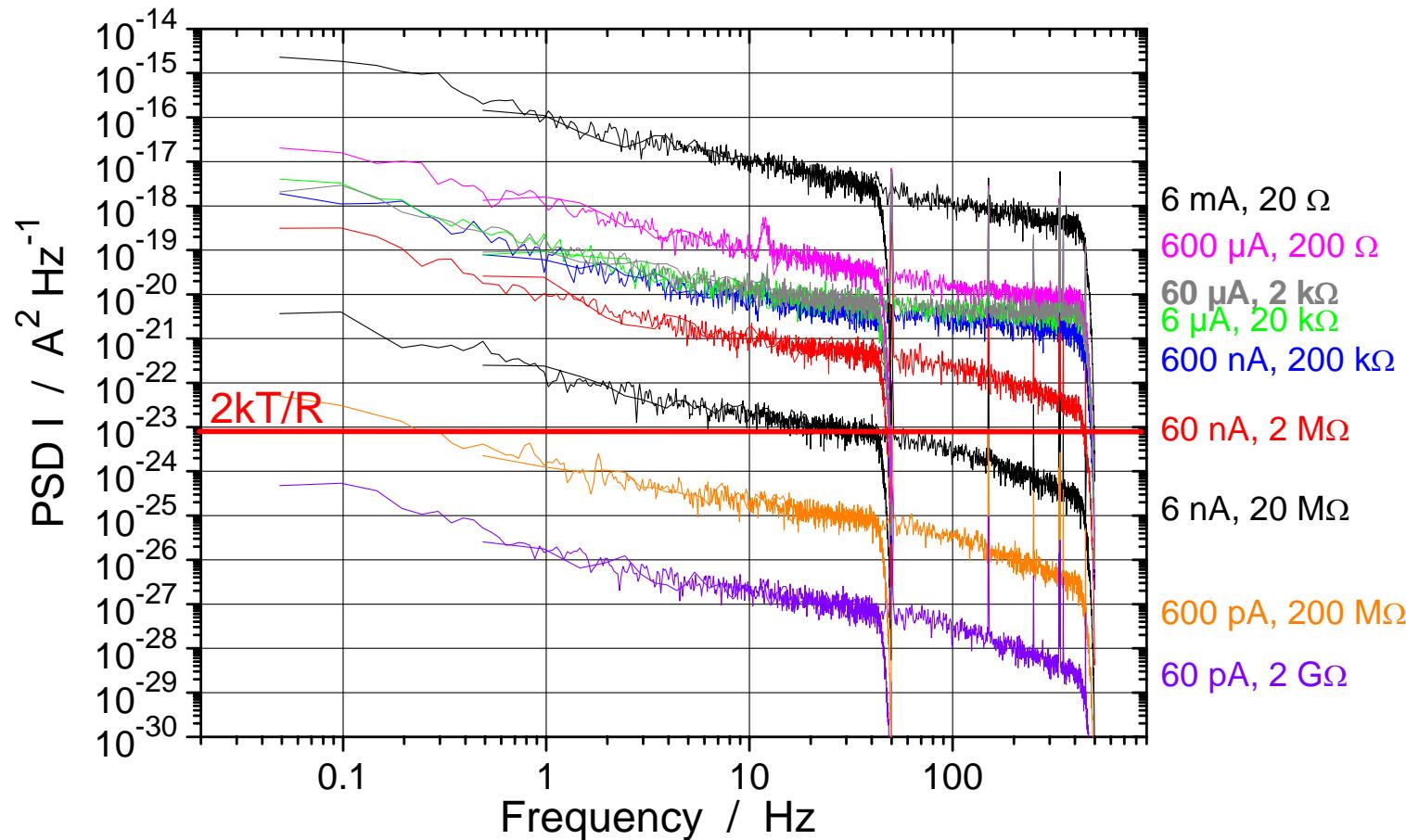
1. Connect all electrodes. Input file name, choose test mode, sampling frequency, test time.
2. Toggle cell on.
3. Set all IE range, Current channel, Voltage channel first to **auto mode**, let the software choose a measure range without overload. **Overload may disappear after 10 to 20 seconds.**
4. Set all IE range, Current channel, Voltage channel to **manual mode**. Try to decrease IE range down to get a minimum setting without overload. Once the overload indicator is triggered **for more than 20 s**, meaning a too-low current range for the measured value, the user should set the range one order up.
5. Decrease voltage channel and current channel manually down to get a minimum range without overload.
6. For the voltage fluctuations, evaluate the peak-to-peak amplitude on the screen during the measurements, and check this value is lower than the Vch range.
7. For the current fluctuations, evaluate the peak-to-peak amplitude on the screen during the measurements, multiply it with the gain in V/A of the I-E given below and check this value is lower than the Ich range.

I/E range	60 pA	600 pA	6 nA	60 nA	600 nA	6 μA	60 μA	600 μA	6 mA	60 mA	600 mA
R <sub>m</sub> in Ω	2 G	200 M	20 M	2 M	200 k	20 k	2 k	200	20	2	0.2
G in V/A	5×10 <sup>10</sup>	5×10 <sup>9</sup>	5×10 <sup>8</sup>	5×10 <sup>7</sup>	5×10 <sup>6</sup>	5×10 <sup>5</sup>	5×10 <sup>4</sup>	5×10 <sup>3</sup>	500	50	5

8. If the EN is expected to increase during the experiment, it may be necessary to use higher I/E , voltage, and current ranges.
9. Start to record EN data.
10. Observe the overload indicators. Once the overload warning, the data may be unreliable.
11. When finish test, toggle cell off.

## Dummy cell : $R = 1 \text{ k}\Omega$

ESA410, v6.04, mode Fast,  $V_{ch} = 30 \text{ mV}$ ,  $I_{ch} = 30 \text{ mV}$  or  $300 \text{ mV}$



How the lowest PSDs can be explained?

*Thanks for your attention*